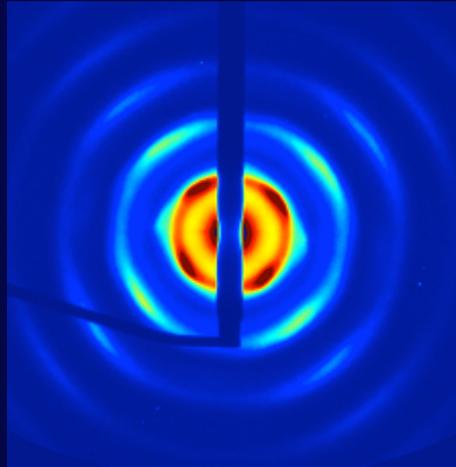


# Small Angle X-Ray Scattering (SAXS) from Bulks and Surfaces



Oleg Gang (ogang@bnl.gov)  
Center for Functional Nanomaterials  
Brookhaven National Laboratory  
Upton, NY, USA

Center for Functional Nanomaterials, one of the 5 Department of Energy premier Nano-centers. Broad range of methods/instruments are open for use (free of charge, via proposal) including the use beamlines



National Synchrotron Light Source II- the world brightest synchrotron (became operational in 2015)



# Outline

- ✓ **Why Scattering and its Basics**
- ✓ **Small Angle X-ray Scattering (SAXS)**
  - ✓ **Scattering from Individual Objects**
  - ✓ **Scattering from Lattices and Complex Organizations**
- ✓ **Surface Scattering**
  - ✓ **Grazing Incidence Small Angle X-ray Scattering (GISAXS)**
  - ✓ **X-ray Reflectivity (XRR)**
- ✓ **Instrumentation and data processing**
- ✓ **Examples of Applications for Material Studies (through the talk)**

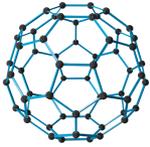
# Probing Different Length-Scales

## Crystallography

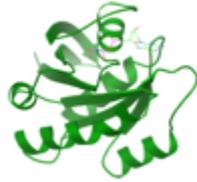
## Microstructure

## Structure

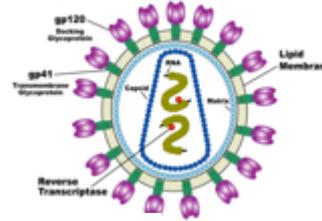
Atomic Structure



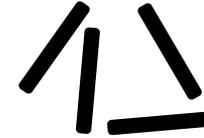
Proteins



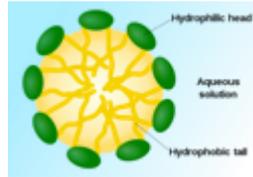
Virus



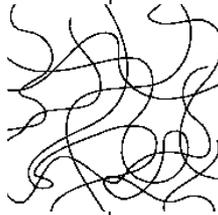
Bacteria



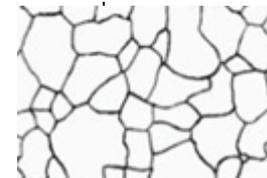
Micelles



Polymers



Grain Structure



Porosity



Precipitates



Optical Microscopy

Electron Microscopy

Electron Diffraction

X-ray Diffraction

X-ray Small Angle Scattering

X-ray Ultra Small Angle Scattering

Neutron diffraction

Neutron Small Angle Scattering

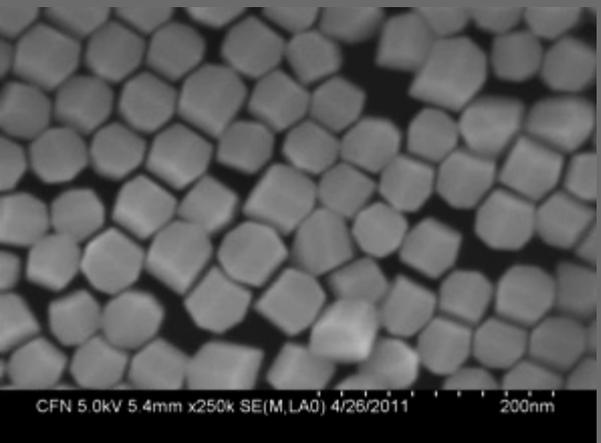
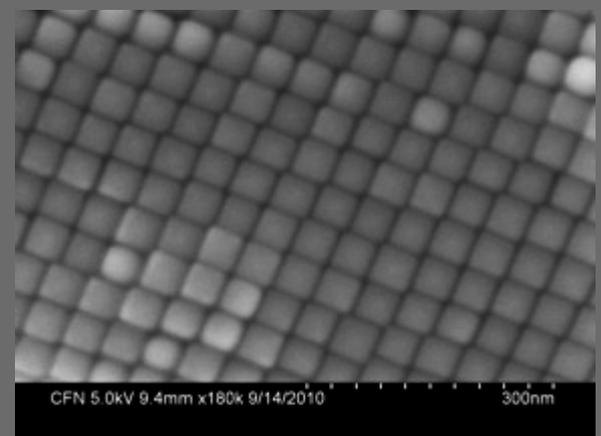
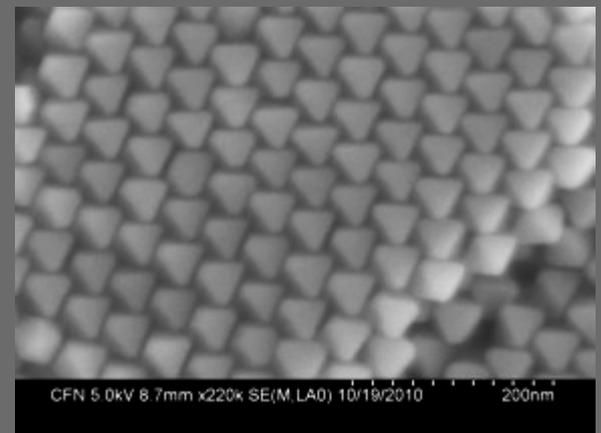
Various Spectroscopy Methods (Inelastic scattering)

$10^{-9}$

$10^{-7}$

$10^{-5}$

# Nanoscale objects: same elements - new properties



IA										VIIA										VIIIA									
1 H 1.00794																				1 H 1.00794	2 He 4.002602								
3 Li 6.941																				5 B 10.811	6 C 12.0007	7 N 14.00674	8 O 15.9994	9 F 18.9984032	10 Ne 20.1797				
11 Na 22.989770	12 Mg 24.3050																				13 Al 26.981538	14 Si 28.0855	15 P 30.973761	16 S 32.066	17 Cl 35.4527	18 Ar 39.948			
19 K 39.0983	20 Ca 40.078	21 Sc 44.955910	22 Ti 47.867	23 V 50.9415	24 Cr 51.9961	25 Mn 54.938049	26 Fe 55.845	27 Co 58.933200	28 Ni 58.6934	29 Cu 63.546	30 Zn 65.39	31 Ga 69.723	32 Ge 72.61	33 As 74.92160	34 Se 78.96	35 Br 79.904	36 Kr 83.80												
37 Rb 85.4678	38 Sr 87.62	39 Y 88.90585	40 Zr 91.224	41 Nb 92.90638	42 Mo 95.94	43 Tc (98)	44 Ru 101.07	45 Rh 102.90550	46 Pd 106.42	47 Ag 107.8682	48 Cd 112.411	49 In 114.818	50 Sn 118.710	51 Sb 121.760	52 Te 127.60	53 I 126.90447	54 Xe 131.29												
55 Cs 132.90545	56 Ba 137.327	57 La* 138.9055	72 Hf 178.49	73 Ta 180.9479	74 W 183.84	75 Re 186.207	76 Os 190.23	77 Ir 192.227	78 Pt 195.078	79 Au 196.96655	80 Hg 200.59	81 Tl 204.3833	82 Pb 207.2	83 Bi 208.98038	84 Po (209)	85 At (210)	86 Rn (222)												
87 Fr (223)	88 Ra (226)	89 Ac** (227)	104 Rf (261)	105 Db (262)	106 Sg (263)	107 Bh (264)	108 Hs (265)	109 Mt (266)	110 Ds (269)	111 Uuu (272)	112 Uub (277)			114 Uug (289)			116 Uuh (289)	118 Uuo (289)											
* Lanthanide series		58 Ce 140.116	59 Pr 140.90765	60 Nd 144.24	61 Pm (145)	62 Sm 150.36	63 Eu 151.964	64 Gd 157.25	65 Tb 158.92534	66 Dy 162.50	67 Ho 164.93032	68 Er 167.26	69 Tm 168.93421	70 Yb 173.04	71 Lu 174.967														
** Actinide series		90 Th 232.0381	91 Pa 231.03588	92 U 238.0289	93 Np (237)	94 Pu (244)	95 Am (243)	96 Cm (247)	97 Bk (247)	98 Cf (251)	99 Es (252)	100 Fm (257)	101 Md (258)	102 No (259)	103 Lr (262)														

Macro gold

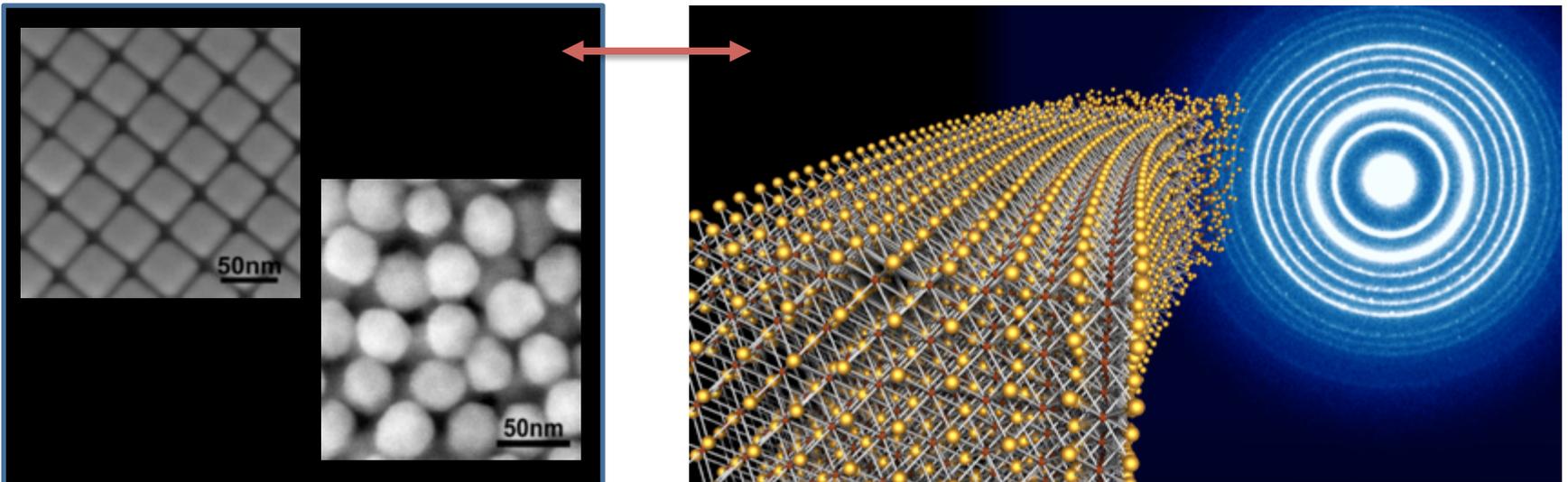


Nano gold

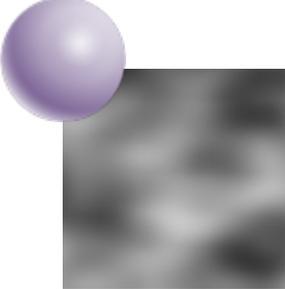
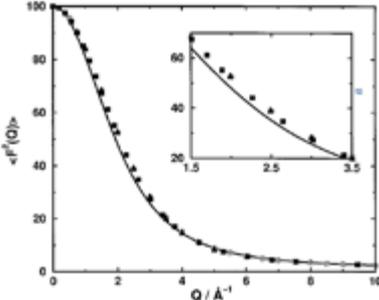
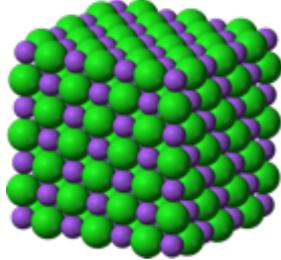
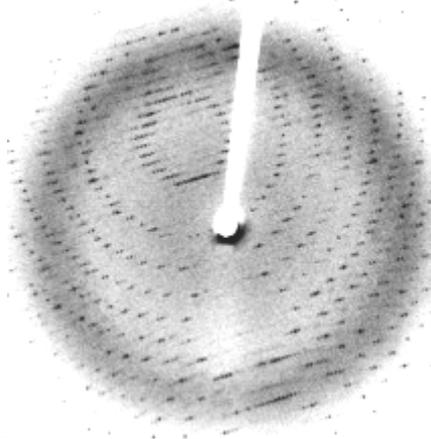
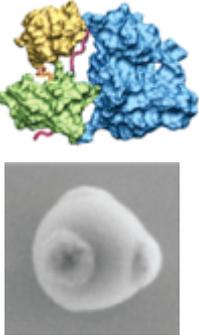
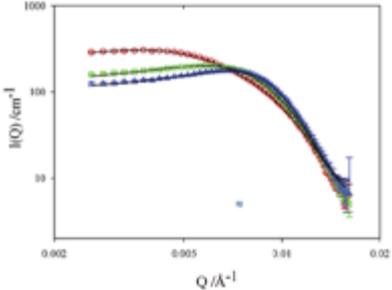
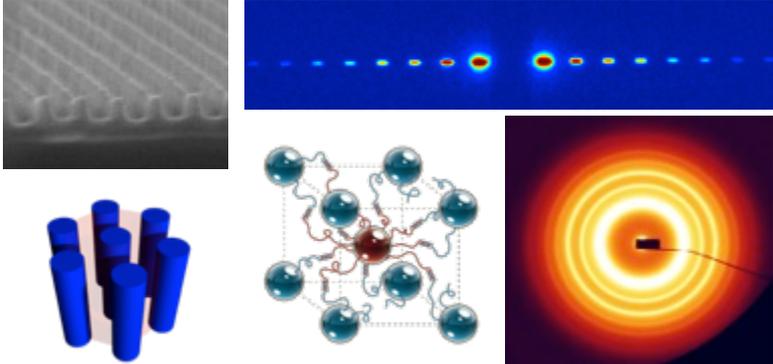


# Why scattering?

- **Advantages:**
  - **Fast**
  - **Meaningful global average instead of just local (spurious?) information**
  - **Can probe buried, 3D structures (instead of surfaces or projections)**
  - **In-situ and non-destructive:**
    - **Can probe in liquid state, *during* transformations, inside functioning devices, ...**
- **Main disadvantage:**
  - **Hard to interpret data**

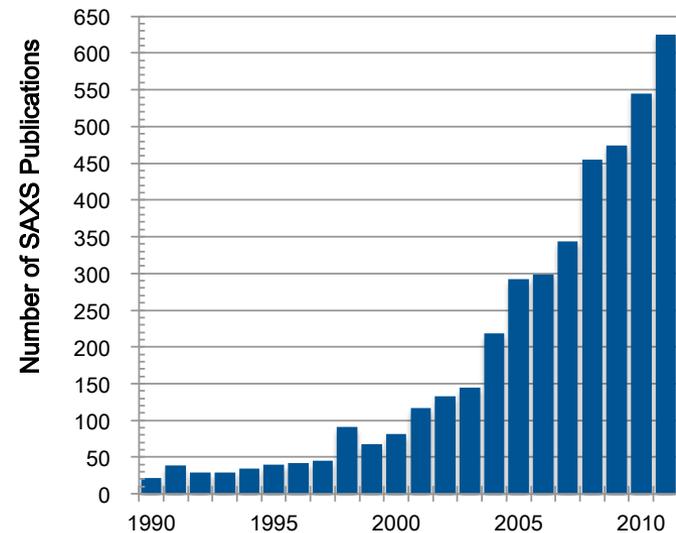
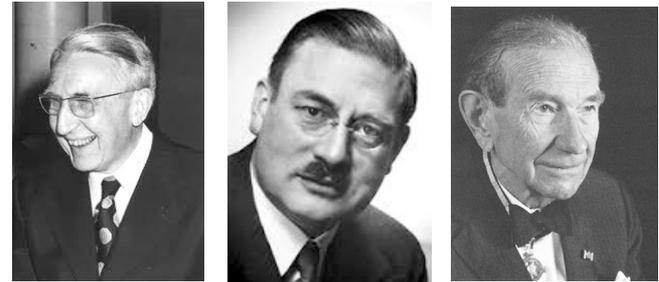


# Different “kinds” of Scattering

		Organization of constituents (“Structure Factor”)	
		Random	Periodic
Constituents (“Form Factor”)	Simple	<p>Gases, liquids, glasses, ...</p>  	<p>Crystals, ...</p>  
	Arbitrary	<p>Colloids, proteins in solution, ...</p>  	<p>Lithography, nano-particle lattices, ...</p> 

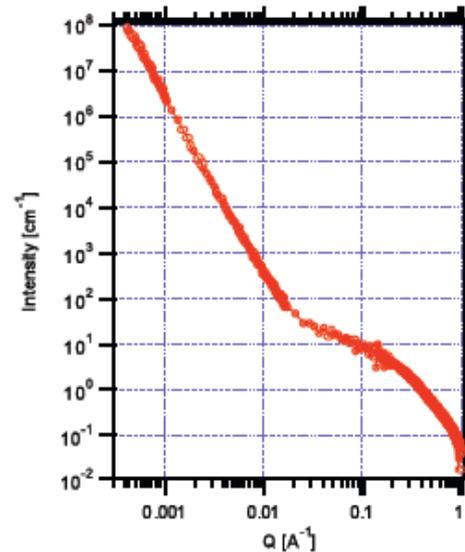
# A Brief History of Small Angle Scattering

- SAS methods were introduced in the 1930s, by André Guinier
- Throughout the 1938 – 1950s, Guinier and others developed SAS fundamentals (inc. Peter Debye, Otto Kratky, Günther Porod)
- First experiments with proteins occurred in the 1950s
- The use of SAS increased with the ‘user friendly’ beamlines that adopted the method.
- Since the mid-1990’s, the number of SAS publications has increased.



# What can We Measure?

- Size of scatterer
- Amount of scatterers
- Polydispersity
- Distribution of scatterers
- Shape of scatterers
- Morphology of scatterers
- Composition of scatterers

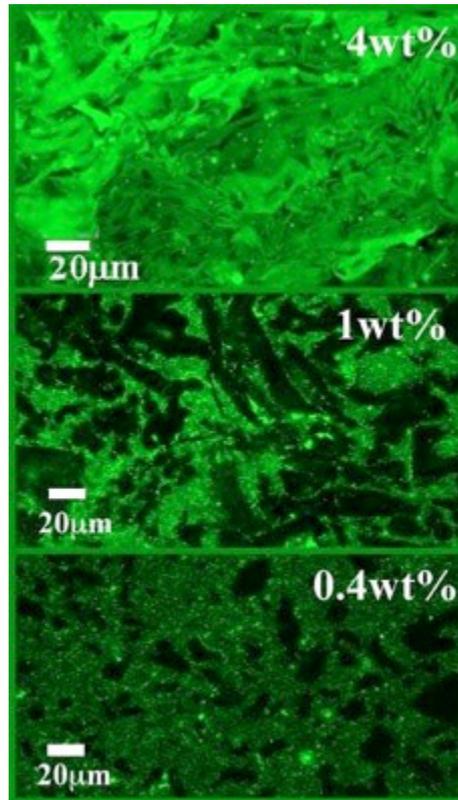


- There is *strong* dependence between some of these terms.
- SAS experiments, *complemented by other measurements*, can yield rich information about the microstructure.

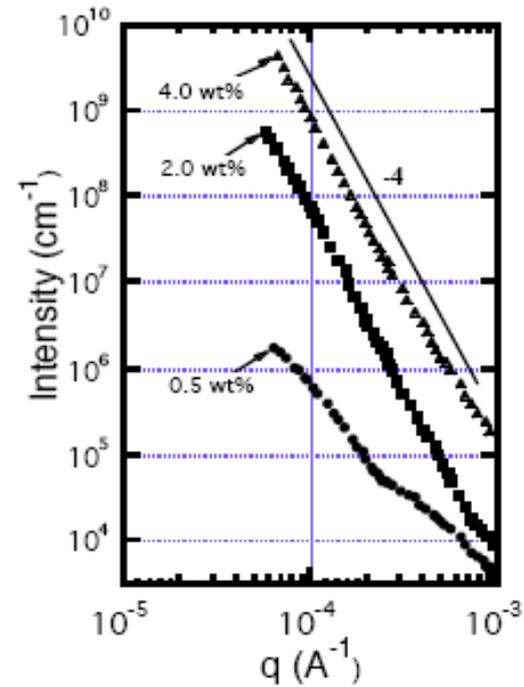
# Scattering vs Imaging: Reveal the Difference

## Hydrogels formed from block copolymer of Lysine and Valine

*Darrin Pochan, U. Delaware*



**Confocal Microscopy**



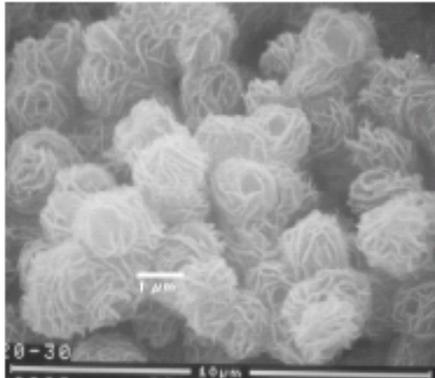
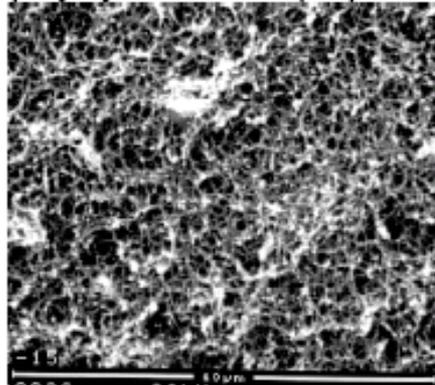
**USANS**

**Images miss differences**

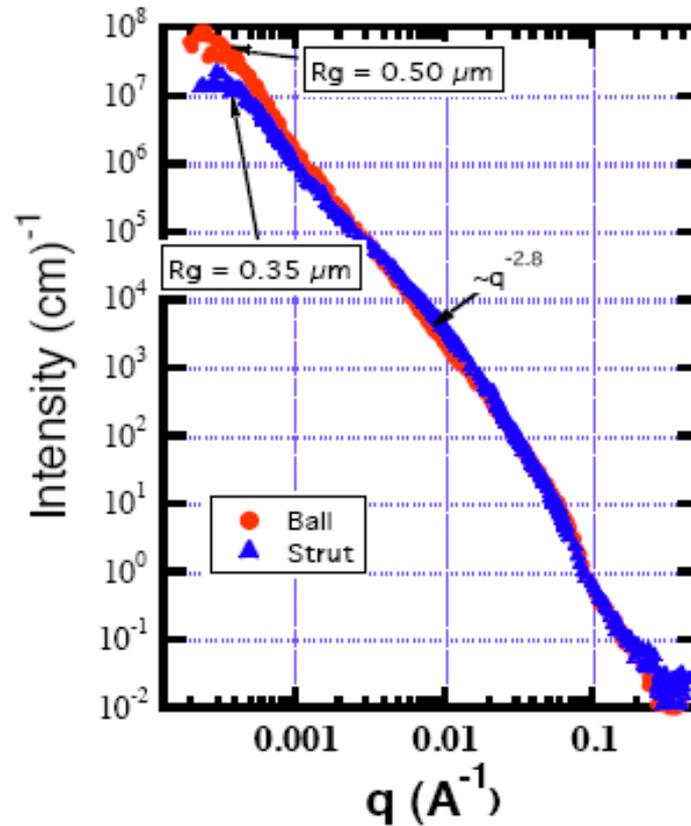
# Scattering vs Imaging: Discover the Similarity

## Isotactic polystyrene foams

Jim Aubert, SNL



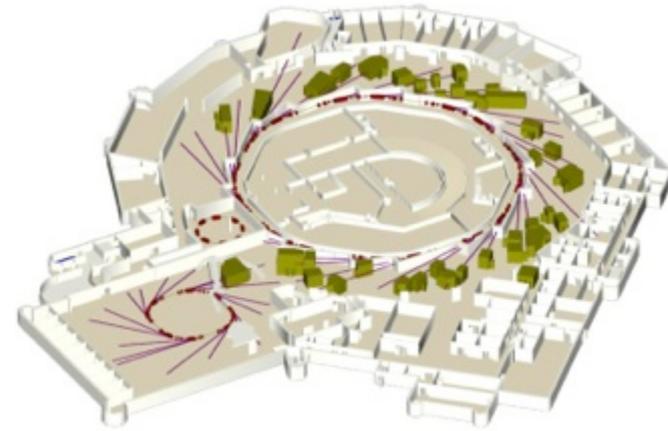
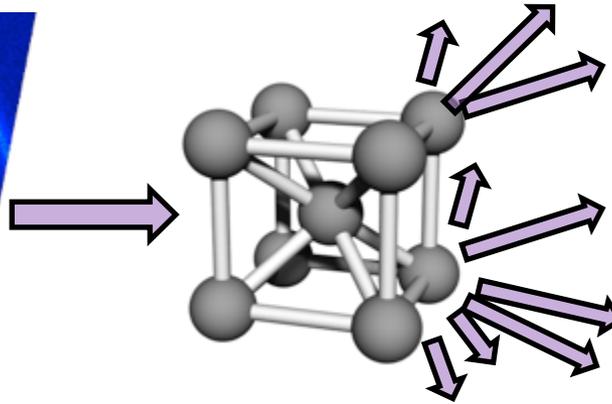
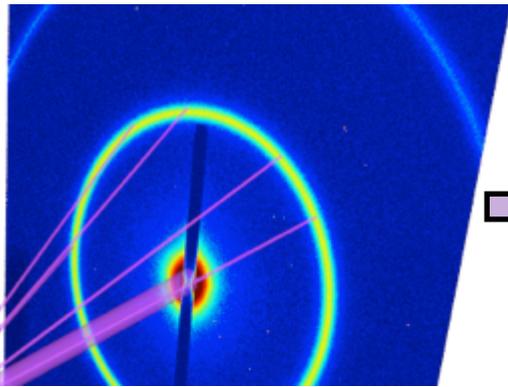
10 μm



Images miss similarity

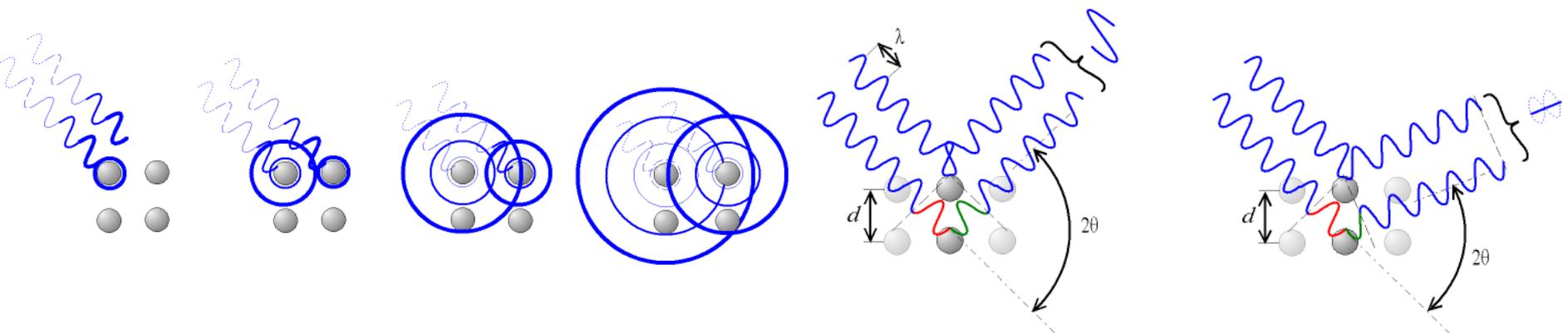
# Scattering methods

- Neutron Scattering - scatter from nucleus, element sensitive
- X-rays scatter off of all the atoms/particles in the sample (sensitive to electron density difference)



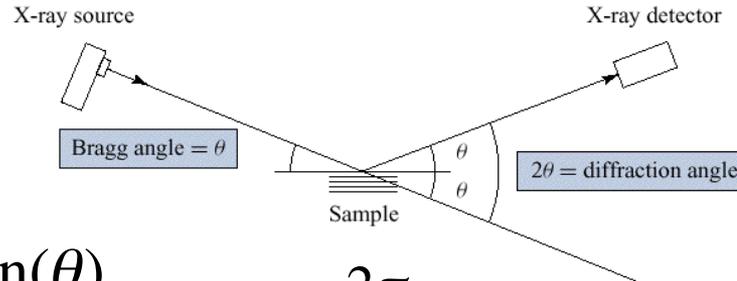
- The scattered waves interfere, which produces distinct spots or rings at specific angles...

$$n\lambda = 2d \sin \theta$$



# Small Angle Scattering

Sizes measured



$$q = 4\pi \frac{\sin(\theta)}{\lambda}$$

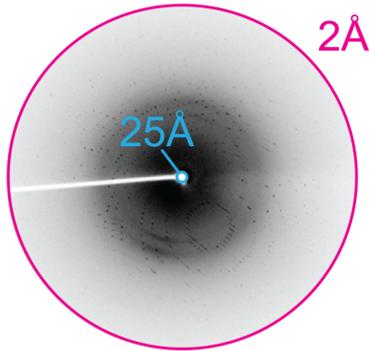
$$d = \frac{2\pi}{q}$$

Q [Å <sup>-1</sup> ]	D [nm]	2Q [deg] 12keV
1	0.6	10
0.1	6	1
0.01	60	0.1
0.001	600	0.01
0.0002	3000 (3 μm)	0.001

Detector dynamic range is important – Intensity  $\sim q^4$

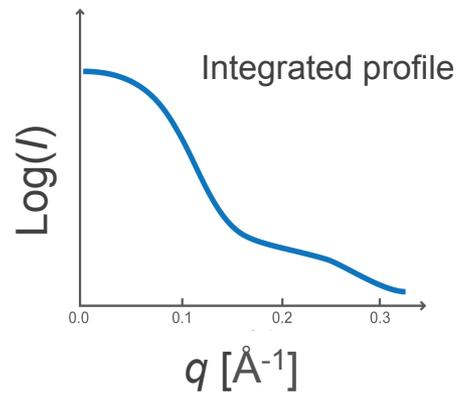
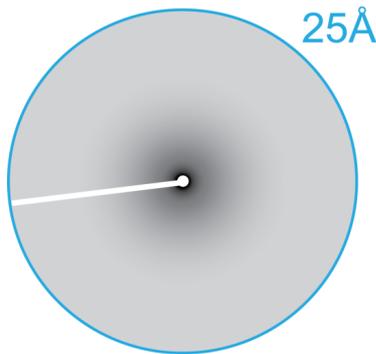
Q or q is wavevector transfer  
D or d is characteristic length

# Crystallography vs. SAXS



hkl	I	$\sigma(I)$
002	14800	450
003	31	28
004	16450	532
005	97	54
006	12950	385
008	17780	620

Advantage	Limitation
Atomic structure information	Requires a crystal
Readily available software	Flexible portions may not be seen



Advantage	Limitation
Analysis in native conditions	Low resolution (10-20 Å)
May see 'floppy' domains not apparent in crystal structures	Modeling ambiguity

# Atomic Form Factor

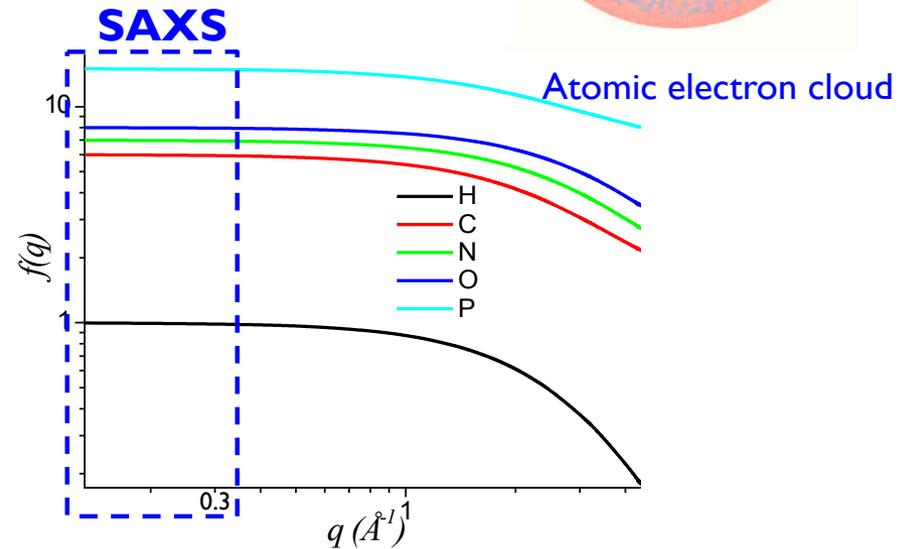
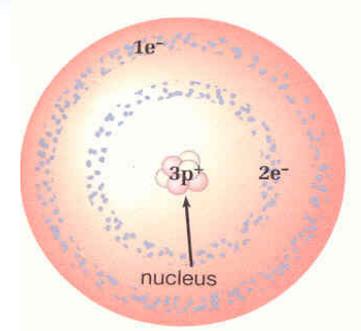
Atomic form factors are fundamental parameters in X-ray techniques.

Electron cloud in atoms has radial density distribution  $\rho(r)$

$$f(q) = 4\pi \int \rho(r) r^2 \frac{\sin(qr)}{qr} dr$$

$\rho(r)$  were obtained from quantum chemical calculations. Atomic form factors for all elements and important ions were tabulated in International Tables for Crystallography and other handbooks.

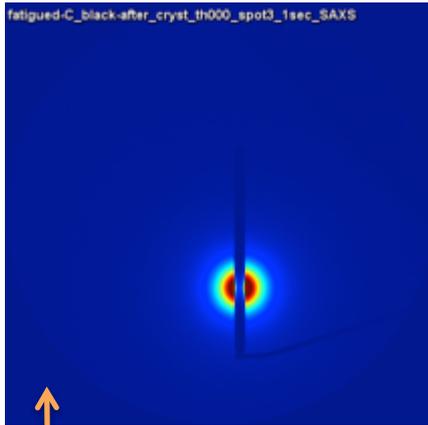
- $f(0) = Z$
- Atoms with higher Z will scatter stronger.
- $f(q)$  decreases slowly along  $q$  in region (SAXS) of  $q$  close to 0
- In low-resolution model reconstruction from SAXS data using  $f(q) = \text{const}$



Data taken from International Tables for Crystallography, Vol. C, Table 6.1.1.1

# Examples of scattering

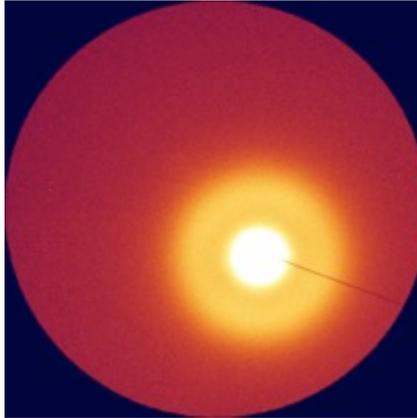
## Diffuse scattering



Multiple length scales.  
Complimentary  
methods are helpful

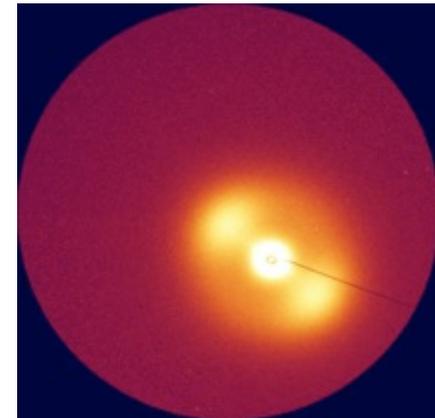
- Large dynamical range of scattering
- Not necessarily a specific features are present
- Integration and background corrections needed

## Weak ordering

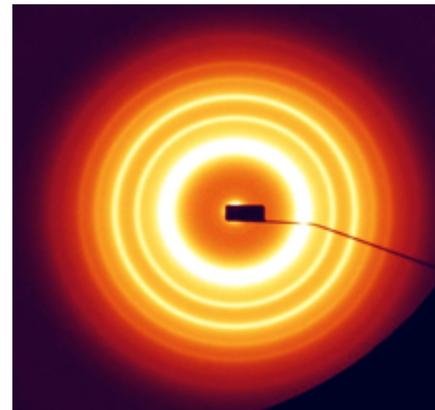


Prevailing length scale  
in the system

## Oriented sample



Oriented sample. Can find  
orientation direction and degree  
of orientation



Small Angle Diffraction  
Well defined periodic  
nanostructures

# What can we see?

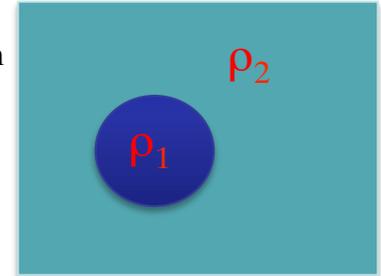
## Scattering length density

Measure of interaction difference of radiation with atoms/molecules in object and surroundings

**LIGHT:** refractive index (electronic structure)

**X-RAYS:** scattering length (electronic structure)

**NEUTRONS:** scattering length (nuclear structure)



Mass density

$$\rho = \frac{\rho_m N_A}{M} \sum_i n_i b_i$$

[units Å<sup>-2</sup>]      Molecular weight

Scattering length

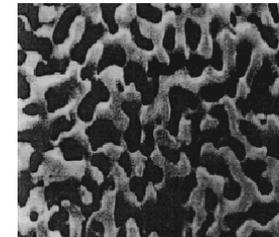
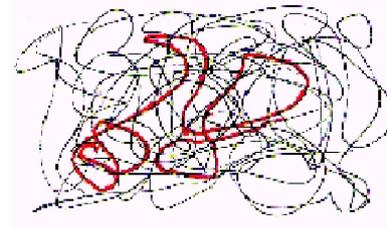
$$b_i = \frac{e^2}{4\pi\epsilon_0 m_e c^2} f_1$$

$$= r_e f_1$$

real part of atomic scattering factor

**Contrast =  $(\rho_1 - \rho_2)^2$**

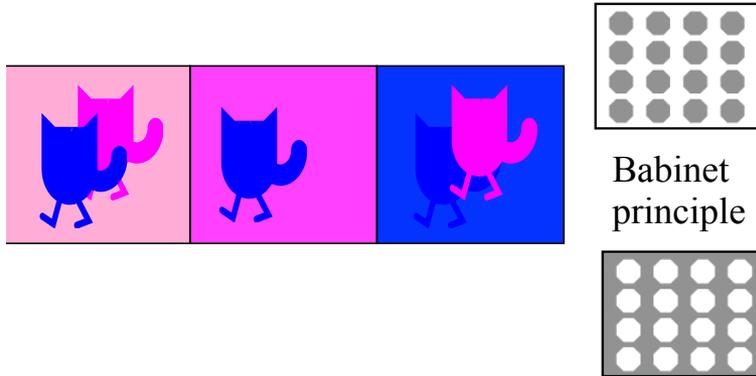
natural (e.g. porous silica and air) or deliberately changed  
valid for n and X-rays (ASAXS)



When the monster came, Lola, like the peppered moth and the arctic hare, remained motionless and undetected. Harold, of course, was immediately devoured.

When the monster came, Lola, like the peppered moth and the arctic hare, remained motionless and undetected. Harold, of course, was immediately devoured.

# Contrast in scattering

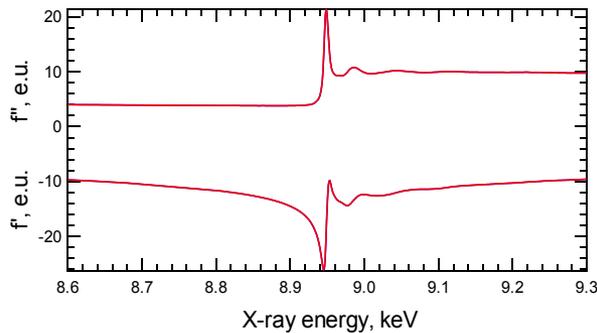


## Atomic Scattering Lengths

Element	Neutrons ( $10^{-12}$ cm)	X-rays ( $10^{-12}$ cm)	Electrons
$^1\text{H}$	-0.374	0.28	1
$^2\text{H (D)}$	0.667	0.28	1
C	0.665	1.67	6
N	0.940	1.97	7
O	0.580	2.25	8
P	0.520	4.23	15

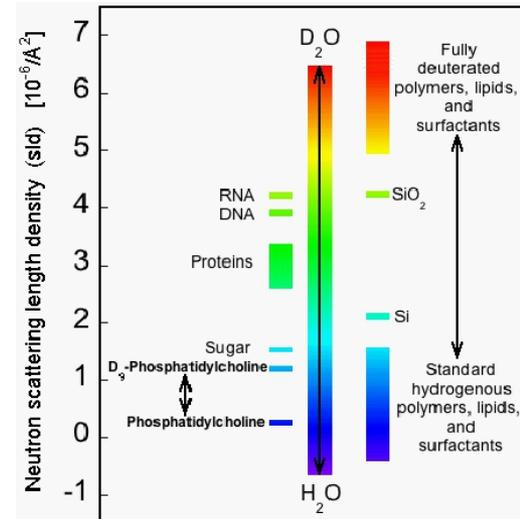
## Anomalous Small-Angle X-ray Scattering

- Why anomalous SAXS?
  - Element-specific contrast variation
  - Use to separate population distributions of scatterers
- Will ASAXS solve every problem?
  - Not even close
  - The easy problems are already taken



## Neutrons

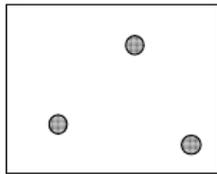
## Contrast matching



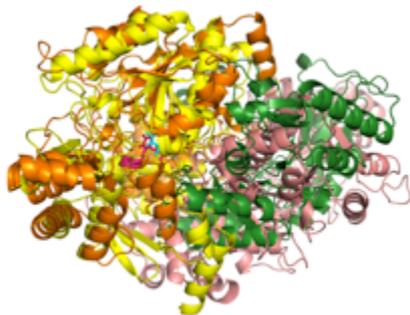
# SAXS is a broad range of methods

*what type of information it can provide?*

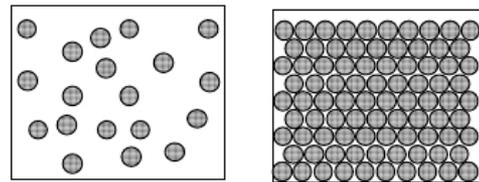
Small angle scattering,  
form factor,  $\sim F(q)$ , (dilute limit)



Same particle size and  
shape



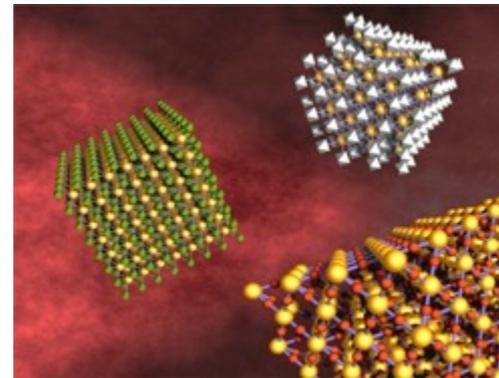
Small angle diffraction,  
form factor,  $\sim S(q)$ , (particles “interact”)



Particle size and shape variations

Same particle size  
and shape

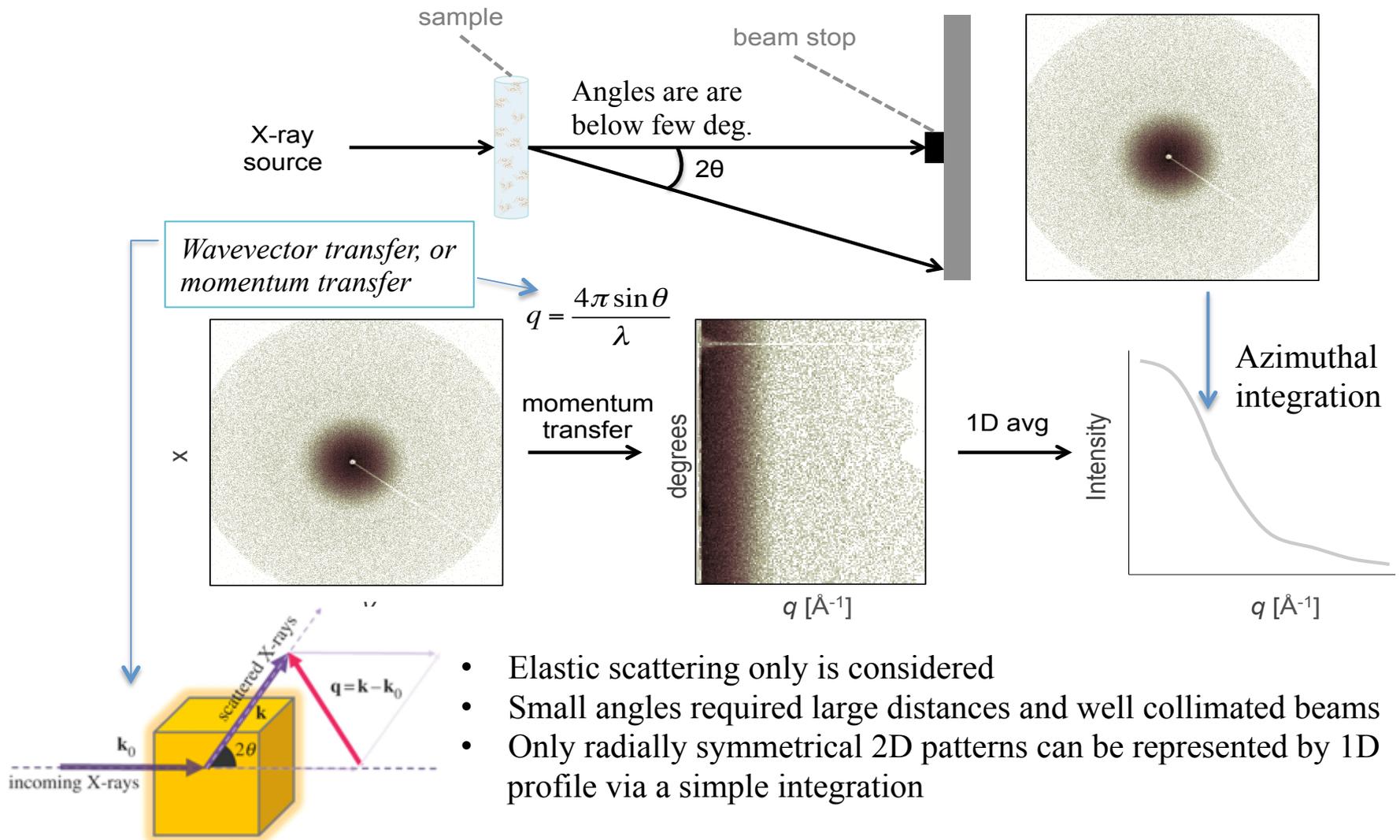
Multiple particle types



# Outline

- ✓ Why Scattering and its Basics
- ✓ **Small Angle X-ray Scattering (SAXS)**
  - ✓ **Scattering from Individual Objects**
  - ✓ Scattering from Lattices and Complex Organizations
- ✓ Surface Scattering
  - ✓ Grazing Incidence Small Angle X-ray Scattering (GISAXS)
  - ✓ X-ray Reflectivity (XRR)
- ✓ Instrumentation and data processing
- ✓ Examples of Applications for Material Studies (through the talk)

# SAXS Experiment



- Elastic scattering only is considered
- Small angles required large distances and well collimated beams
- Only radially symmetrical 2D patterns can be represented by 1D profile via a simple integration

# SAXS from Molecular Solutions

Atomic apparent form factor / contrast :

$$A_j(q) = f_j(q) - g_j(q)$$

atomic form factor in vacuum
form factor of excluded solvent

X-ray scattering total amplitude:

$$\sum_j A_j \exp(i\vec{q} \cdot \vec{r}_j)$$

In solution, X-ray beam sees all orientations of molecules :

$$I(q) = \langle I(\vec{q}) \rangle_{\Omega} = \left\langle \left\langle \sum_j A_j \exp(i\vec{q} \cdot \vec{r}_j) \right\rangle_{\Omega} \right\rangle_{\Omega}^2$$

loss of phase information
loss of angular direction

$$= \sum_j \sum_k A_j A_k \frac{\sin(qr_{jk})}{qr_{jk}} = \sum_j A_j^2 + 2 \sum_j \sum_{k>j} A_j A_k \frac{\sin(qr_{jk})}{qr_{jk}}$$

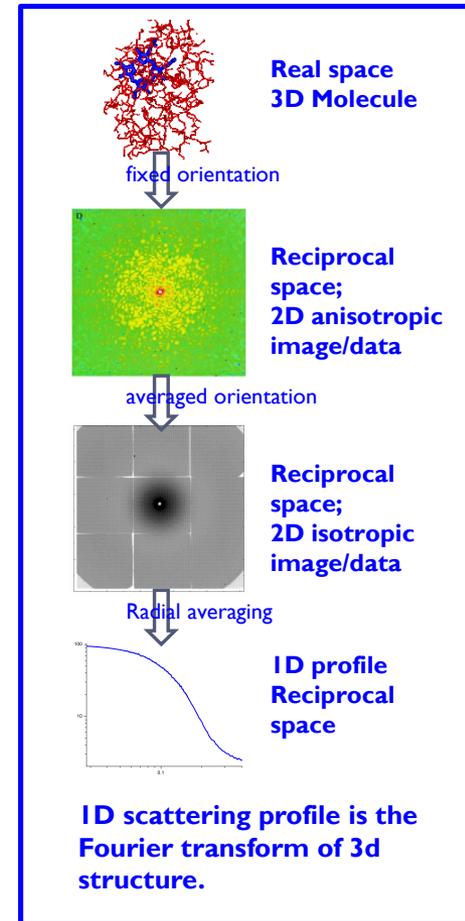
Atom pair distance / Structural information

Individual contribution

interference

Solution x-ray scattering is a 1D profile which encodes molecular structural information.

*form factors of particles j and k can be used in a similar way*



Depends on structure/interactions

# What do we measure in SAXS?

Measured quantity

$$I(q) \propto \frac{d\Sigma(q)}{d\Omega} = \frac{N}{V} V_{particle}^2 (\rho_1 - \rho_2)^2 P(q) S(q)$$

Dilute = independent scatterers = NO interparticle effects

Total intensity = sum of individual particle scattering

$$I(q) \propto \frac{N}{V} V_{particle}^2 (\rho_1 - \rho_2)^2 P(q) \cancel{S(q)}$$

$P(q)$  = Form factor - SHAPE and SIZE information

$P(q)$  is dimensionless and  $P(0) = 1$

*\* In the literature, as in this presentation, both  $P(q)$  and  $F(q)$  are commonly used symbols for form factors*

# Form Factor for Sphere

The form factors of some objects with simple shapes have analytical formula expression, for example, sphere. Sphere is a widely used model in characterizing the size or size distribution of globular particles in structural biology and nanoscale material science.

Sphere with homogenous electron density and radius  $R$ :

$$F(q) = \frac{3(\sin(qR) - qR \cos(qR))}{(qR)^3}$$

$$I(q) = F^2(q) = \left( \frac{3(\sin(qR) - qR \cos(qR))}{(qR)^3} \right)^2$$

From the scattering curve, we can estimate the radius of the sphere:

$$R \approx \frac{4.493}{q_{01}}$$

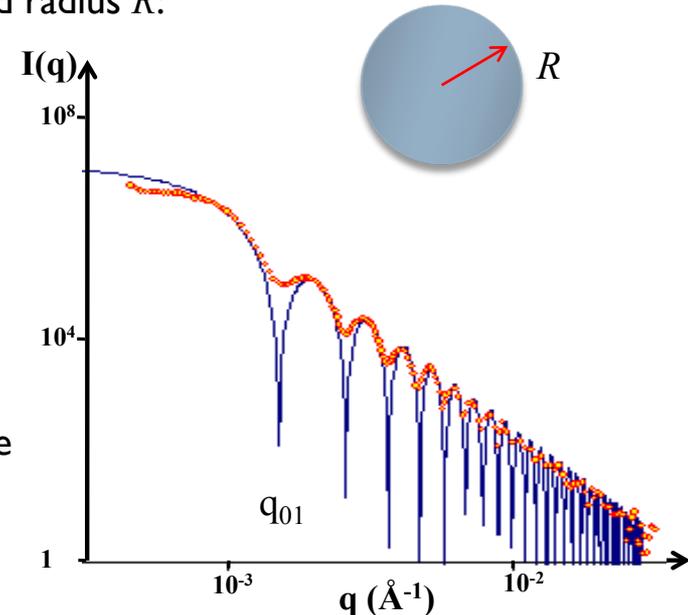
For centro-symmetric object:

$$A(\vec{q}) = \int \rho(\vec{r}) \exp(-i\vec{q} \cdot \vec{r}) d\vec{r}$$

$$A(q) = 4\pi \int_0^R \rho(r) \frac{\sin(qr)}{qr} r^2 dr = 4\pi \int_0^R \frac{\sin(qr)}{qr} r^2 dr$$

$$= \frac{4\pi}{q} \int_0^R \sin(qr) r dr = \dots \quad (\text{partial integration}) \dots$$

$$= \frac{4}{3}\pi R^3 \frac{3[\sin(qR) - qR \cos(qR)]}{(qR)^3}$$

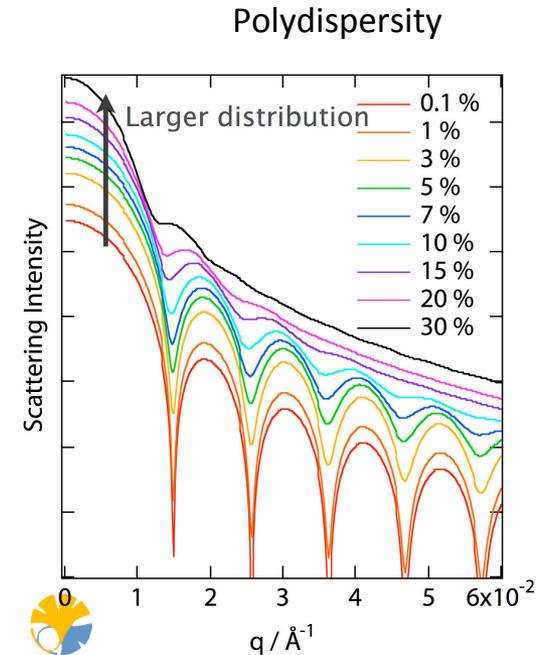
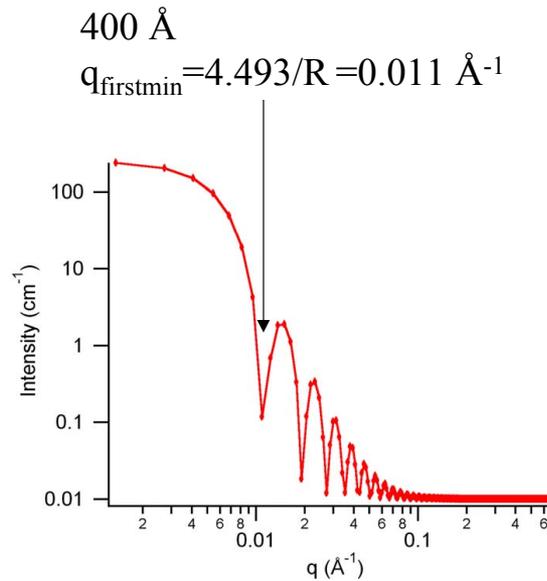
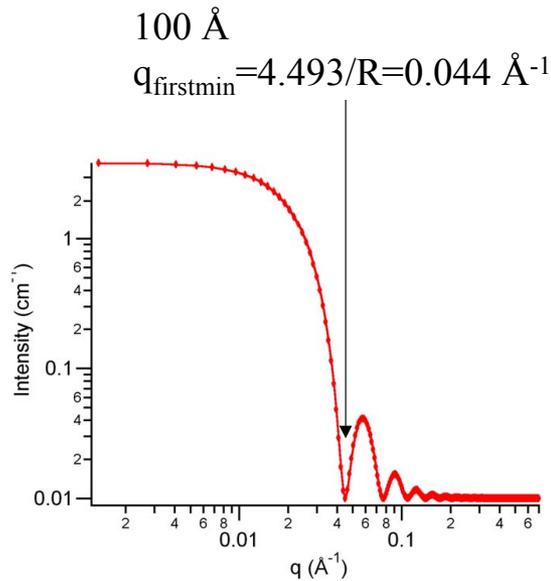


- Scattering profile of silica spheres (red) and simulation based on perfect sphere (blue)
- Discrepancy of silica scattering from sphere model due to size polydispersity, imperfect spherical shape, etc.

Figure modified from: Lambard, Lessieur and Zemb, J. Phys. I France, 1992, (2) 1191

# Effect of Particle Size and Polydispersity

(volume fraction = 1%, contrast =  $10^{-6} \text{ \AA}^{-2}$ , bkgd = 0.01)



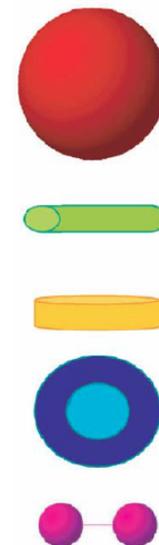
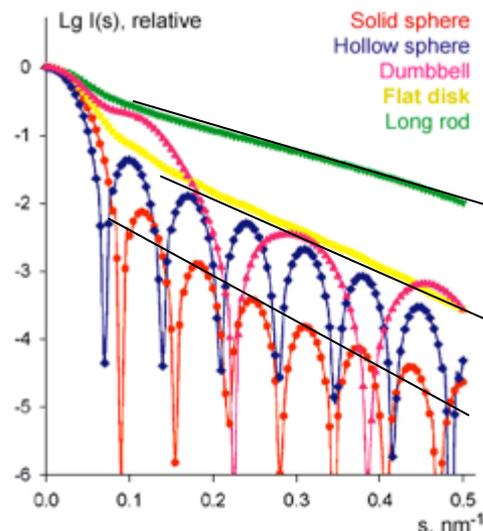
- Instrument resolution can significantly affect the data, masking “true” size distribution, the sample might be not so bad (polydisperse) as it might look
- Resolution should be accounted to separate effect of polydispersity

# Scattering from Individual Shaped Objects

## Common Form Factors of Shaped Objects (many more were computed numerically)

## SAXS Scattering

Morphologies	$P(q)$ or $P^2(q)$ – depends on source	Morphologies
<b>Spheres</b> (radius :R)	$\frac{9}{(qR)^6}[\sin(qR) - qR \cdot \cos(qR)]^2 = A_{\text{sph}}^2(qR)$	
<b>Spherical shells</b> (outer radius: $R_1$ inner radius: $R_2$ )	$\frac{[R_1^3 \cdot A_{\text{sph}}(qR_1) - R_2^3 \cdot A_{\text{sph}}(qR_2)]^2}{(R_1^3 - R_2^3)^2}$	
<b>Triaxial ellipsoids</b> (semiaxes: a,b,c)	$\int_0^1 \int_0^1 A_{\text{sph}}^2[q \sqrt{a^2 \cos^2(\pi x/2) + b^2 \sin^2(\pi x/2)(1-y^2)_1 + c^2 y^2}] dx dy$	
<b>Cylinders</b> (radius: R length: L)	$4 \int_0^1 \frac{J_1^2[qR\sqrt{1-x^2}]}{[qR\sqrt{1-x^2}]^2} \frac{\sin^2(qLx/2)}{(qLx/2)^2} dx$ <i><math>J_1(x)</math> is the first kind Bessel function of order 1</i>	
<b>Thin disk</b> (radius: R)	By setting $L = 0$ $\frac{2 - J_1(2qR)/qR}{q^2 R^2}$	
<b>Long rod</b> (length: L)	By setting $R = 0$ $\frac{2}{qL} \int_0^{qL} \frac{\sin(t)}{t} dt - \frac{\sin^2(qL/2)}{(qL/2)^2}$	

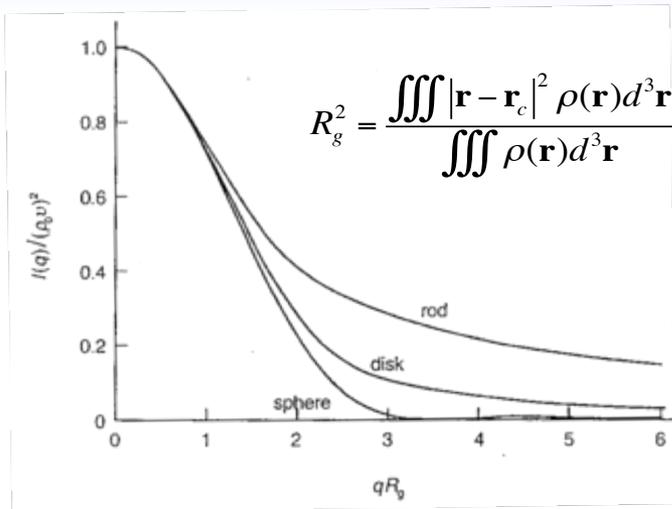


“Structure Analysis by Small Angle X-Ray and Neutron Scattering” L. A. Feigen and D. I. Svergun

$$I(q) \sim q^{-\alpha}$$

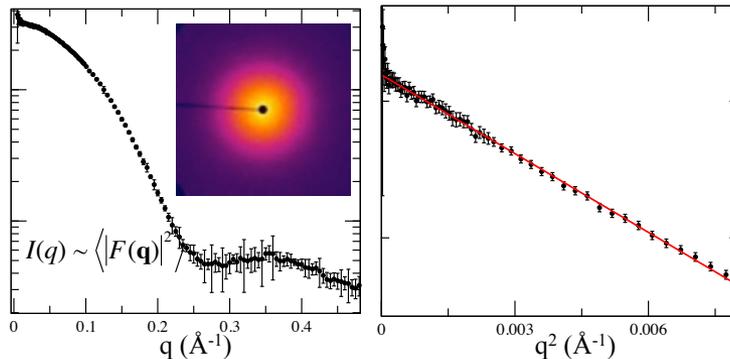
$$\alpha = \begin{cases} 3 & \text{Sphere} \\ 2 & \text{Disk} \\ 1 & \text{Rod} \end{cases}$$

# Radius of Gyration and Guinier Law



The characteristics of objects are encoded in the low- $q$  scattering via **radius of gyration ( $R_g$ )**-calculated as the root mean square distance of the object's parts from its center of gravity

Sphere		Thin rod	Thin disc	Cylinder	
$R_g^2 = \frac{3}{5} R^2$		$R_g^2 = \frac{L^2}{12}$	$R_g^2 = \frac{R^2}{2}$	$R_g^2 = \frac{d^2}{8} + \frac{L^2}{12}$	



**Guinier Law** (valid when  $qR_g < 1.3$ )

$$I(q \rightarrow 0) \sim I_0 \exp(-q^2 R_g^2 / 3)$$

$$\ln I(q) \sim \ln I_0 - \frac{R_g^2}{3} q^2$$

- Guinier Law allows finding  $R_g$  without any model assumption
- The Guinier region of the scattering data would not be linear if sample contains aggregation

# Determining $R_g$ from Guinier Plots

- Guinier Law

$$\ln[I(q)] \cong -\frac{q^2 R_G^2}{3} + \ln[I(0)]$$

$R_g$  – radius of gyration

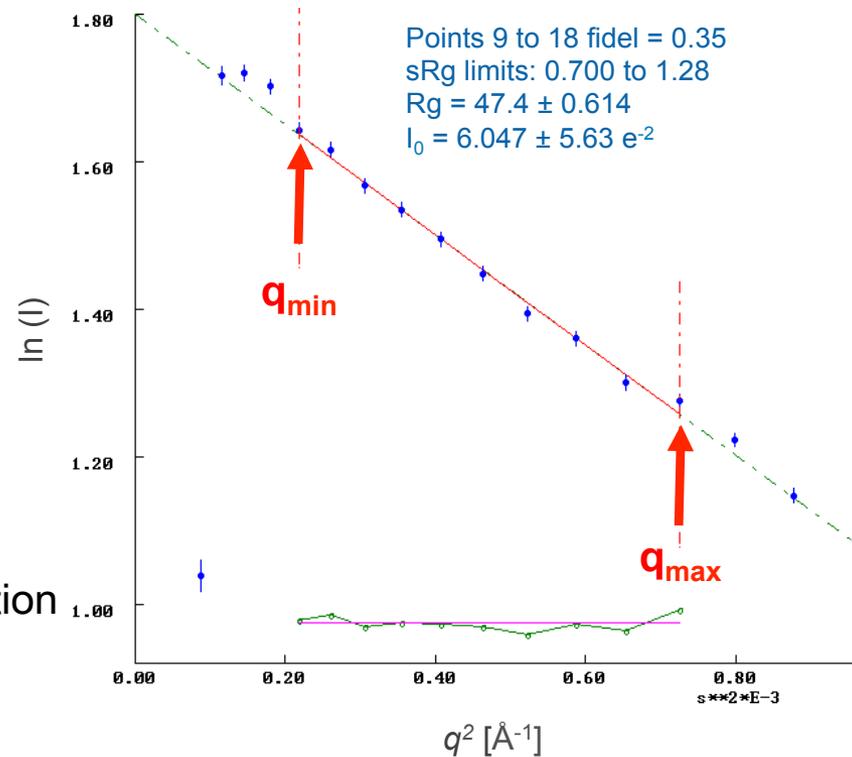
$I(0)$  – forward scattering

- Plot  $\ln I$  vs.  $q^2$

- $q\text{-min} < q < 1.3R_G^{-1}$
- Slope  $\propto R_g$
- Check for linearity

- $I(0)$  gives an independent estimation of the molar mass of the protein.

Requires accurate protein concentration determination

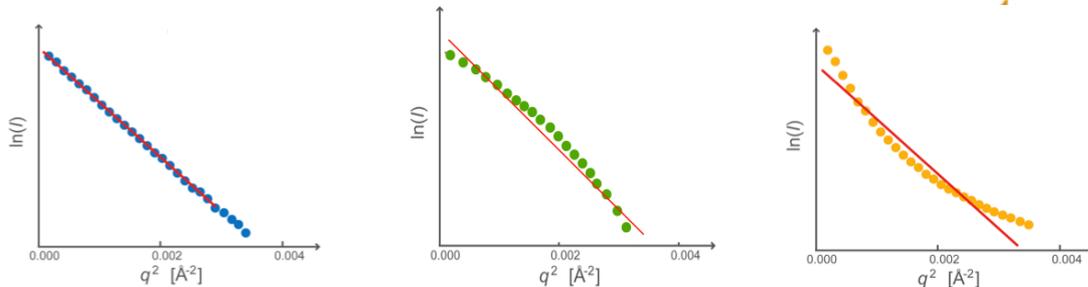


Comptes Rendus Hebdomadaires Des Seances De L Academie Des Sciences 1938, 206:1374-1376

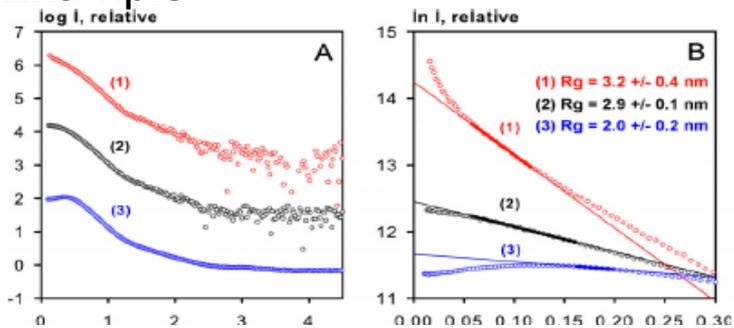
Petoukhov, et. al., *J. Appl. Cryst.* 40, s223 (2007)

# Guinier Law Examples

- Deviant Guinier Plots aren't necessarily 'bad' as they tell you something about the state of the macromolecule in solution



- BSA Example



BSA

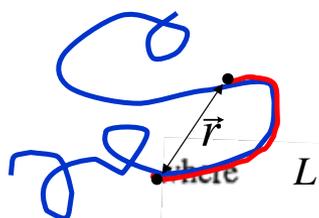
- aggregated
- 'good' data
- inter-particle repulsion

*Journal of Structural Biology 172 (2010) 128*

# Basics for Interpreting Guinier plots

- What is the  $q_{\min}$  in your experimental data?
  - For very large particles, you will need a lower  $q_{\min}$  to use the Guinier region for  $R_g$  determination.
  - This will also be determined by the number of data points in your 1D profile.
- The  $q_{\max}$  will depend on the shape of your molecule.
  - For spherical particles,  $q_{\max} < 1.3 \cdot R_g$
  - For elongated particles,  $q_{\max} < 0.8 \cdot R_g$
- The Guinier also provides  $I(0)$ , which is proportional to the # of electrons in the scattering particle (MW).

# Scattering from Polymers



Polymer chain is not compact object,  $r$  described by Gaussian

$$I(q) \sim D(x)$$

Debye function

$$D(x) = \frac{2(e^{-x} + x - 1)}{x^2}, \quad x = \frac{q^2 N l^2}{6} = q^2 \langle R_g^2 \rangle$$

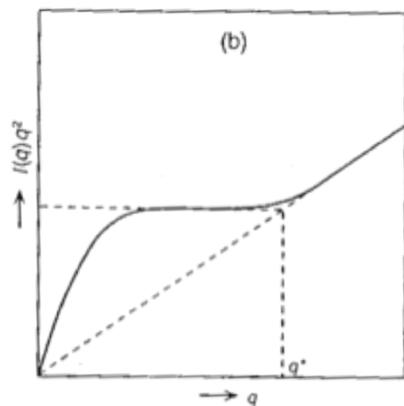
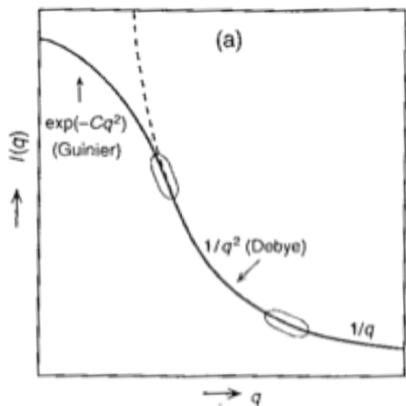
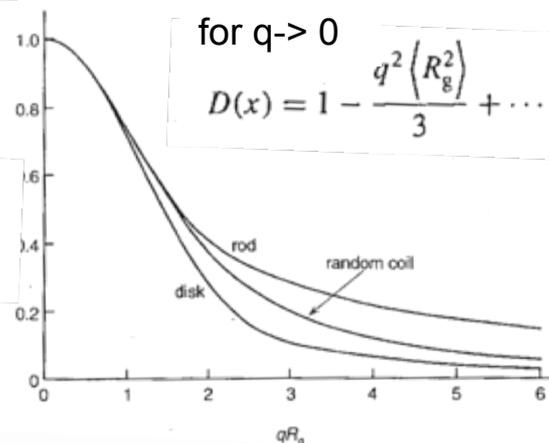
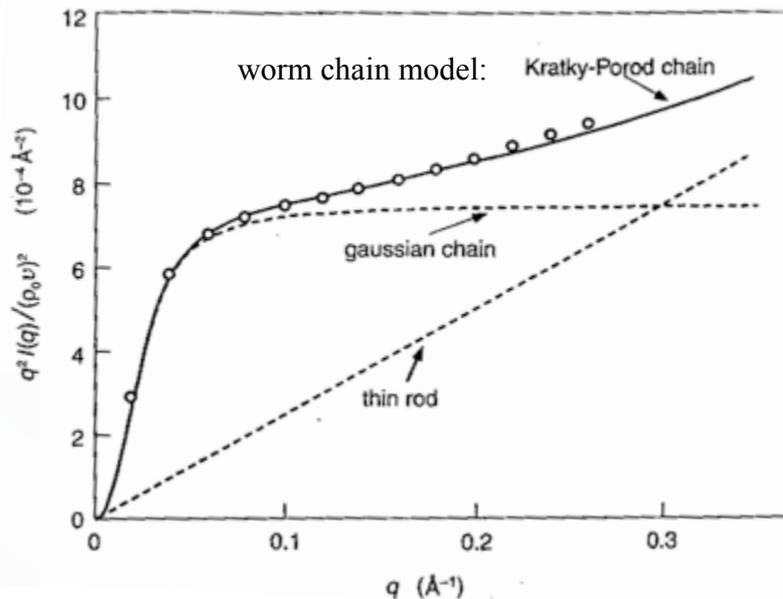
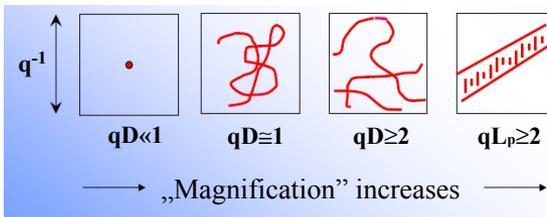


Figure 5.5 (a, b) Schematic presentation of the expected characteristics of the single chain scattering function in different  $q$  regions. (After Kratky and Porod.<sup>11,13</sup>)

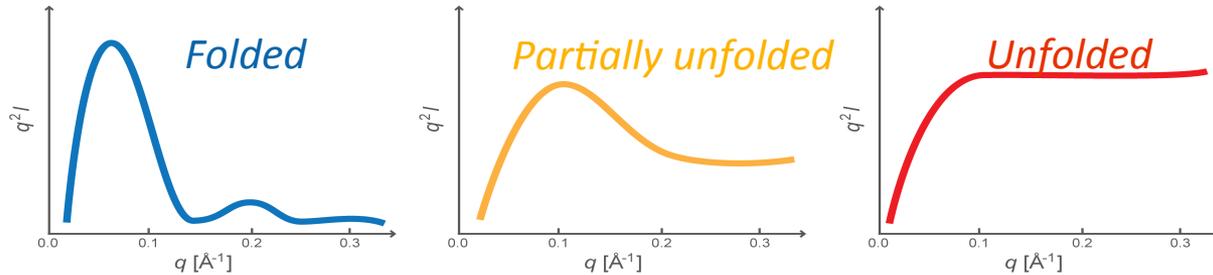
- Zooming into different  $q$  ranges reveal polymer structure on different scales



# Kratky Plot ( $Iq^2$ vs $q$ ):

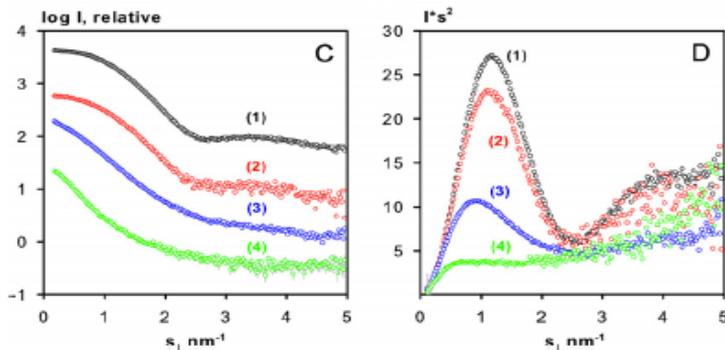
*revealing polymer/macromolecule structure (compactness)*

- Plot  $Iq^2$  vs.  $q$ .
- Differentiation between folded and unfolded protein



- Compact (i.e. folded) macromolecules exhibit a bell-shaped curve in a Kratky Plot
  - $I(q)$  vs.  $q^2$ ,  $I(q)$  vs.  $q^4$
- Extended (i.e. unfolded) macromolecules have plateau at higher  $q$

## Kratky Plot examples



Lysozyme

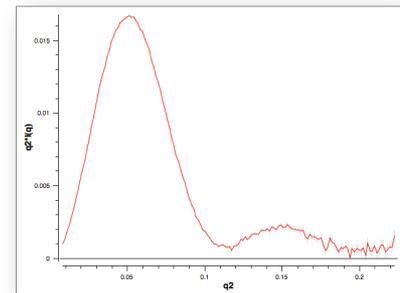
- 1) folded
- 2) Partially folded (8 M urea)
- 3) Partially folded ( $90^\circ \text{C}$ )
- 4) Unfolded (8 M urea at  $90^\circ \text{C}$ )

*Journal of Structural Biology 172 (2010) 128–141.*

## Porod Invariant

- Porod invariant,  $Q$ , is the integral of the area of the Kratky curve

$$Q = \int_0^{\infty} I(q)q^2 dq$$

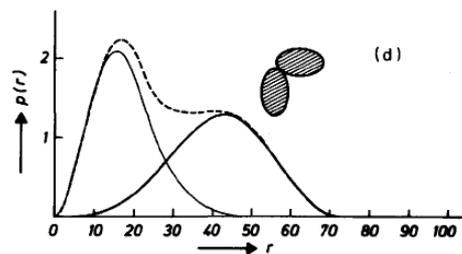
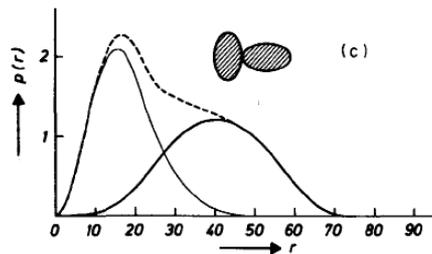
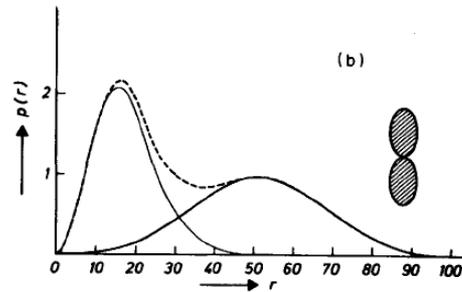
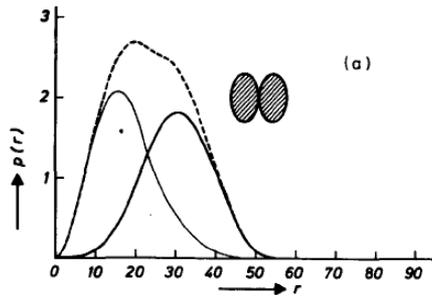


- $Q$  is a concentration independent value and is proportional to **molecular mass**.

# Distance distribution function

$P(r)$ : distance distribution function is related to the frequencies of distances within particle

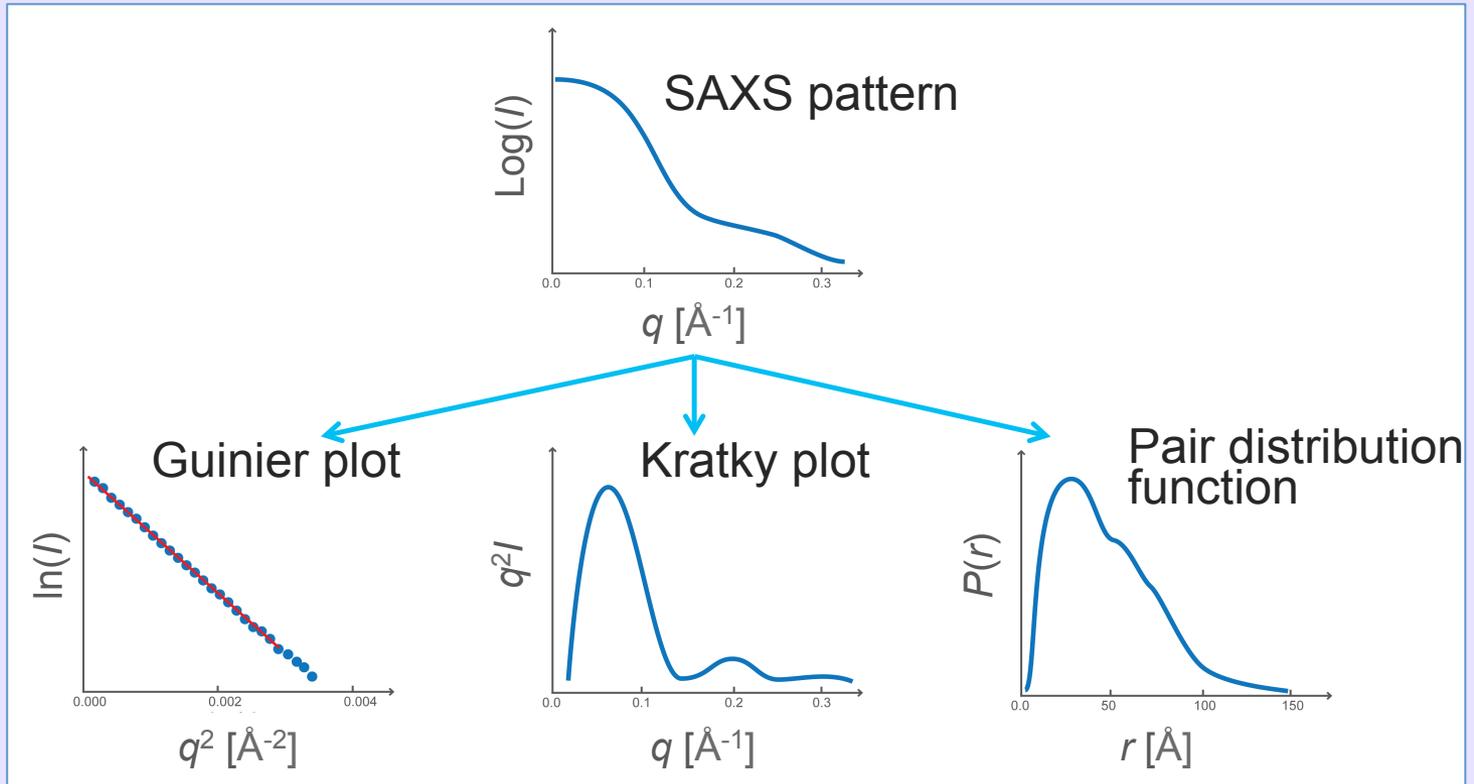
$$P(r) = r^2 \int_0^{\infty} I(q) \frac{\sin(qr)}{qr} 4\pi q^2 dq$$



- Calculation of  $P(r)$  from data in limited  $q$ -range requires specialized algorithm

Glatter and Kratky  
Small Angle X-ray Scattering

# Deriving Information from SAXS Data

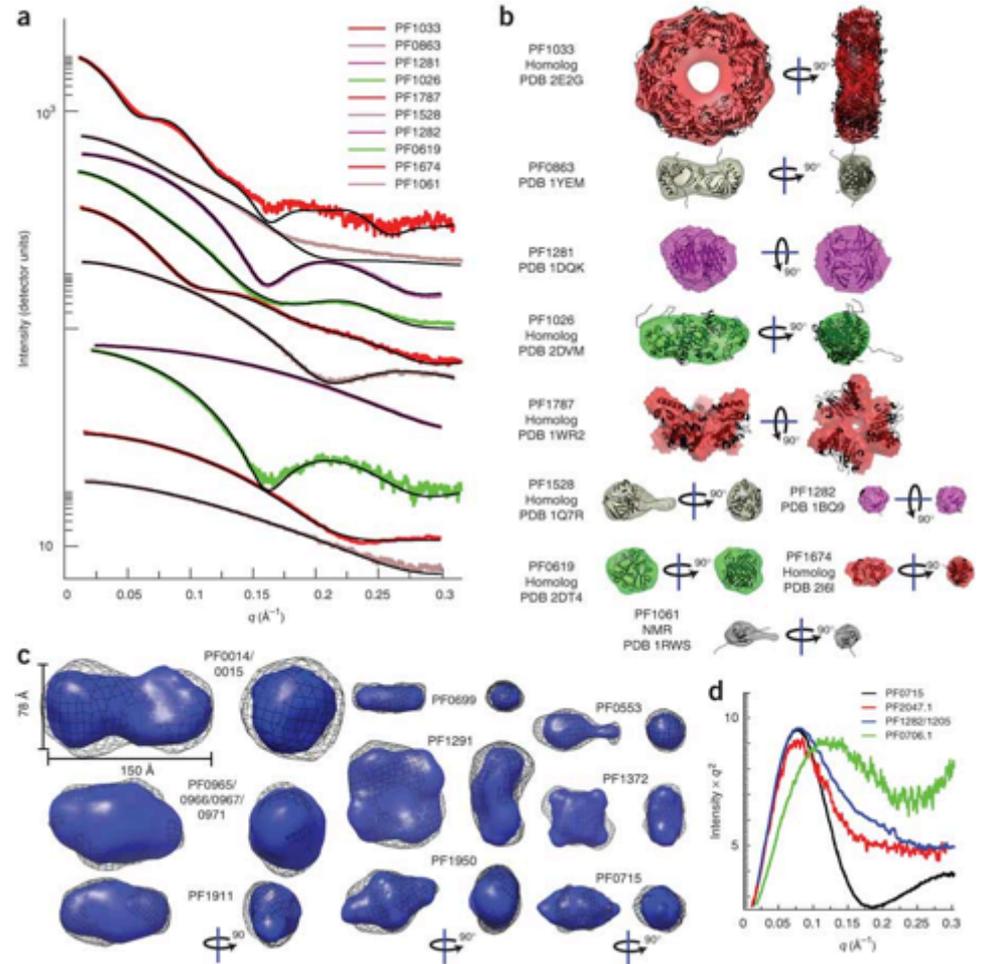
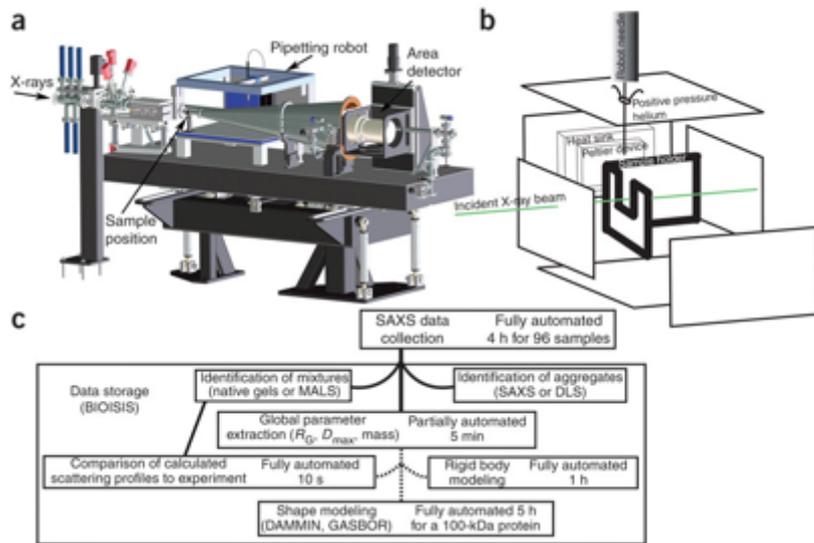


**$R_g$**

**Compactness**

**Shape**

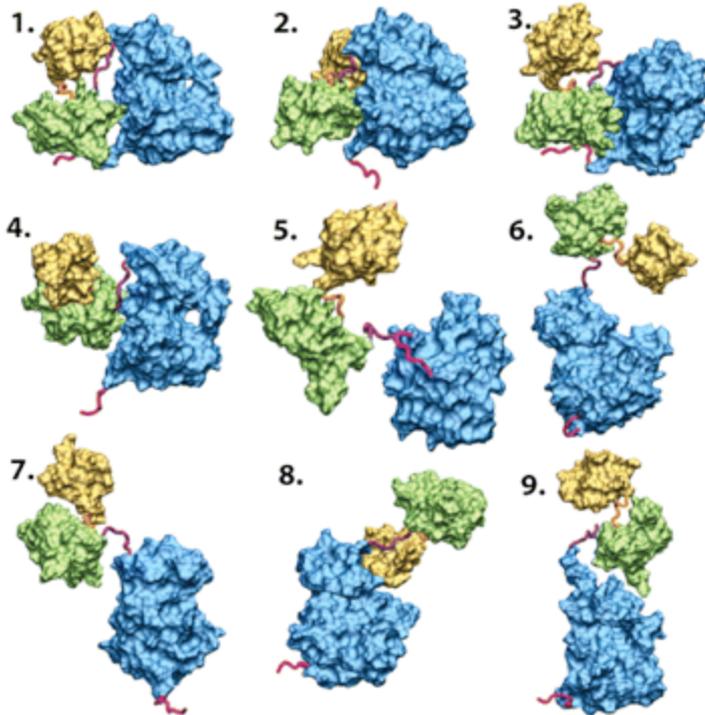
# Applications of SAXS: Complex Protein Structures can be Revealed in situ



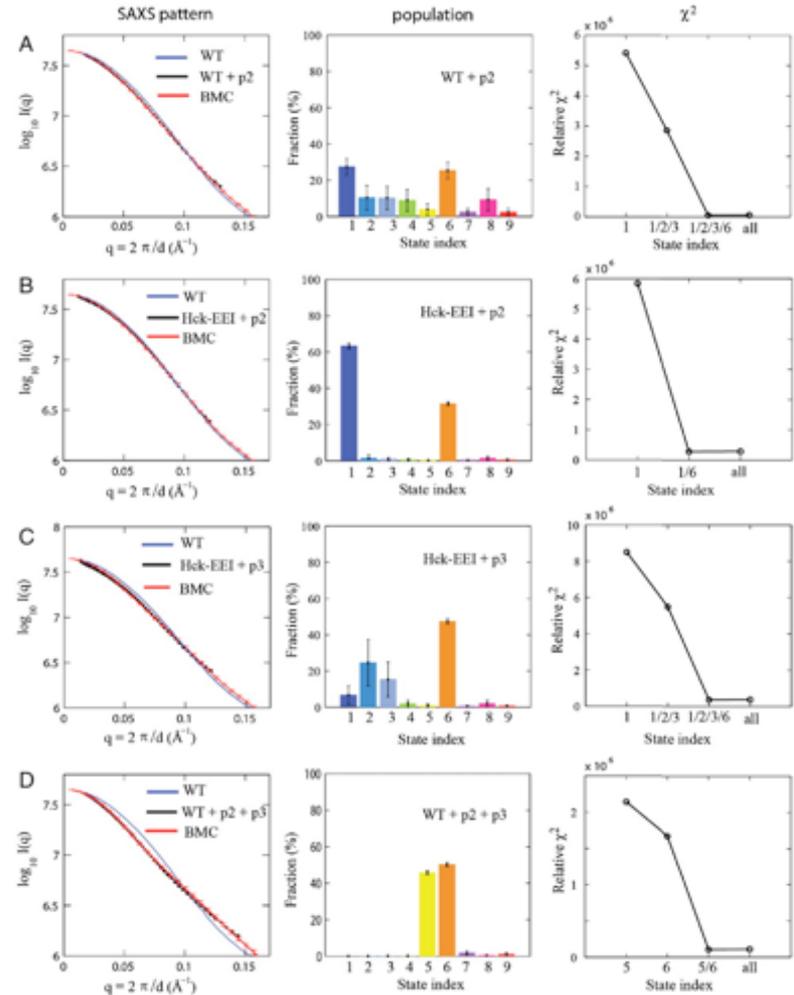
Hura et al, Nature Methods 6, 606 (2009)

# Molecular flexibility

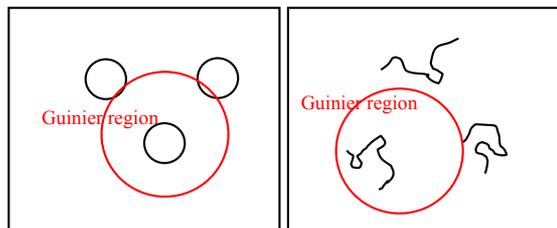
## Conformation of Hck tyrosine kinase in solution



- Flexible structures can/should be modeled as an ensemble of multiple conformations



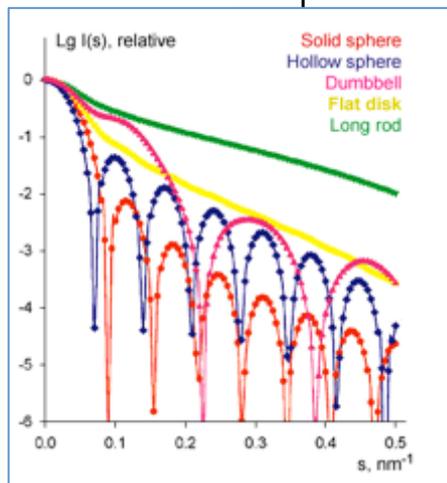
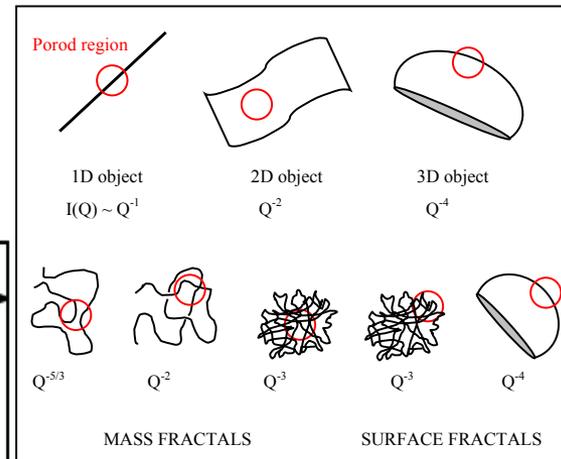
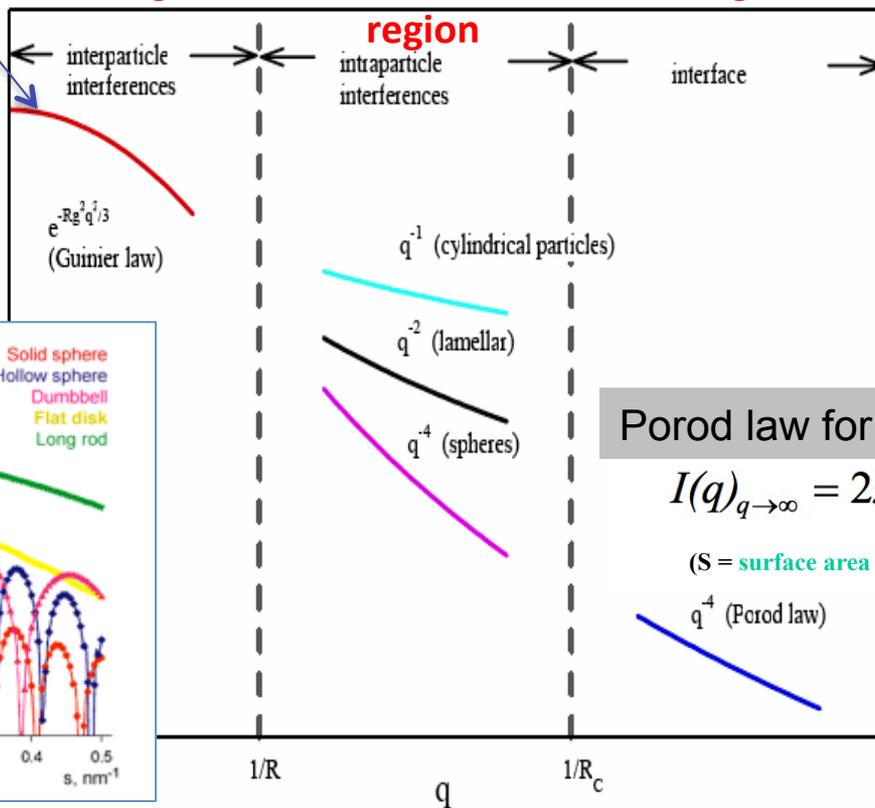
# Scattering Regions



1. region

2. region

3. region



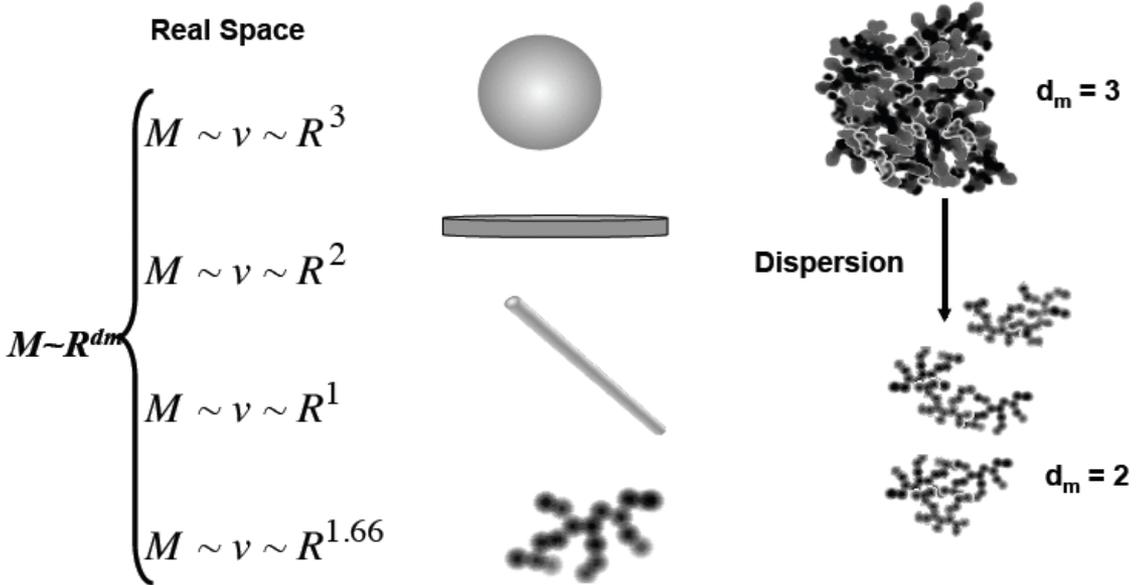
Porod law for smooth particle

$$I(q)_{q \rightarrow \infty} = 2\pi S(\rho_1 - \rho_2)^2 q^{-4}$$

(S = surface area per unit volume)

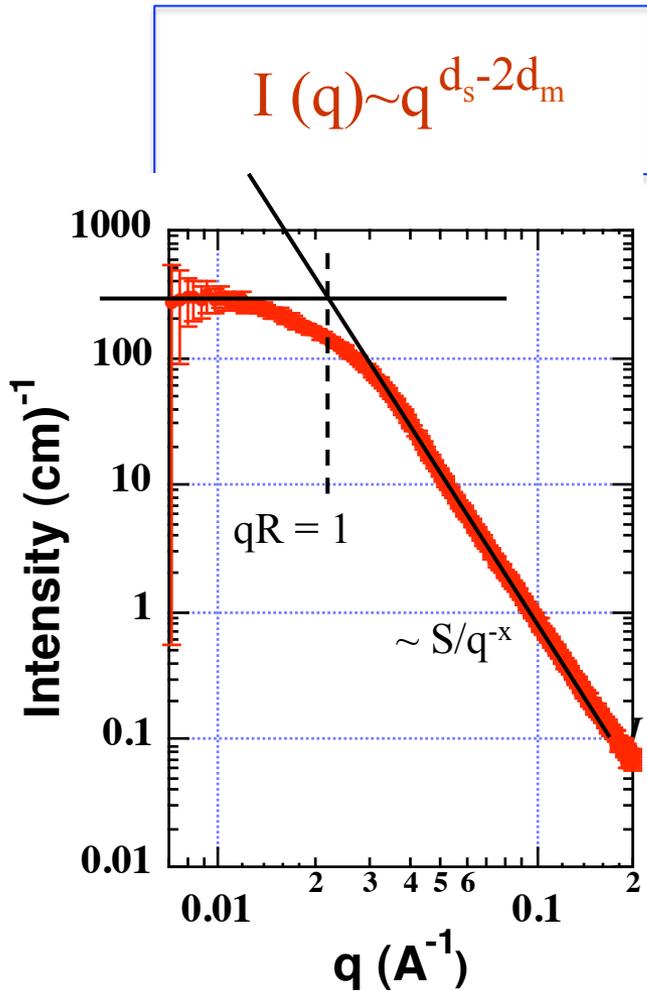
$$q^{-4} \text{ (Porod law)}$$

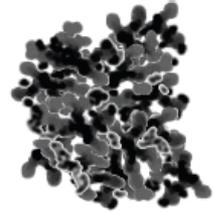
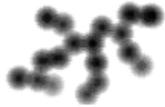
# Mass Fractal



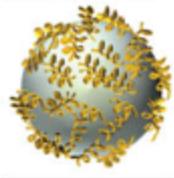
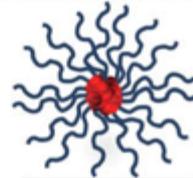
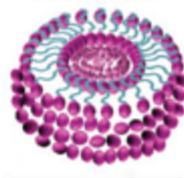
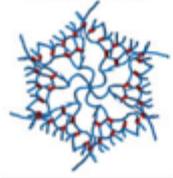
Mass fractal dimension  $d_m$

# Scattering Behavior



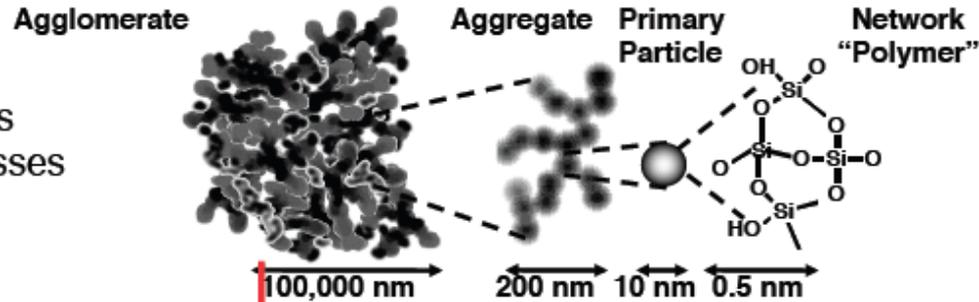
Structure	Scaling relation	Porod Slope $d_s - 2d_m$ $qR \gg 1$
Smooth Surface 	$d_m = 3$ $d_s = 2$	-4
Rough Surface 	$d_m = 3$ $2 < d_s < 3$	$-3 \leq \text{Slope} \leq -4$
Mass Fractal 	$1 \leq d_m = d_s \leq 3$	$-1 \leq \text{Slope} \leq -3$

Nanoparticles	Polymeric micelles	Liposomes	Dendrimers	Polymer-drug conjugates
				
50-200 nm	20 nm	40-400 nm	1-10 nm	6-15 nm

# Hierarchical structure – analysis

Four Length Scales  
Four Morphology Classes

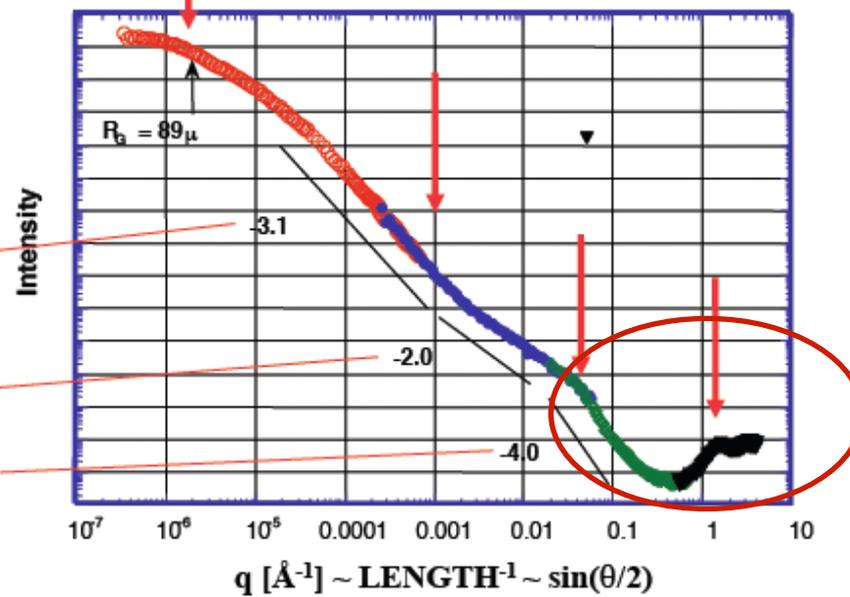


$$q = \frac{2\pi}{d_{\text{bragg}}} = \frac{4\pi}{\lambda} \sin\left(\frac{\theta}{2}\right)$$

Surface Fractal

Mass Fractal

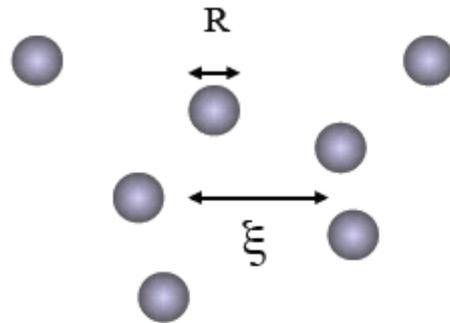
Smooth



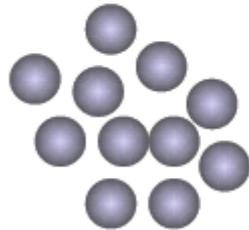
# Outline

- ✓ Why Scattering and its Basics
- ✓ **Small Angle X-ray Scattering (SAXS)**
  - ✓ Scattering from Individual Objects
  - ✓ **Scattering from Lattices and Complex Organizations**
- ✓ Surface Scattering
  - ✓ Grazing Incidence Small Angle X-ray Scattering (GISAXS)
  - ✓ X-ray Reflectivity (XRR)
- ✓ Instrumentation and data processing
- ✓ Examples of Applications for Material Studies (through the talk)

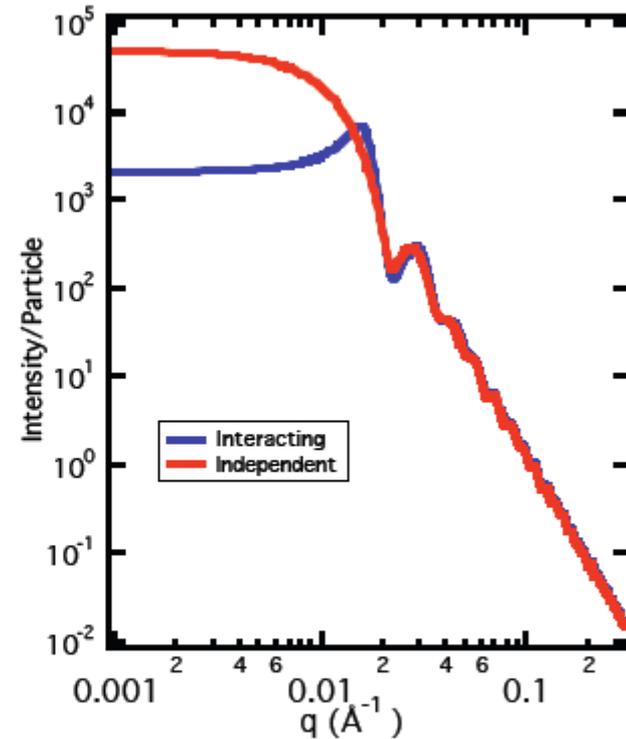
# Interference Effects



Gas like



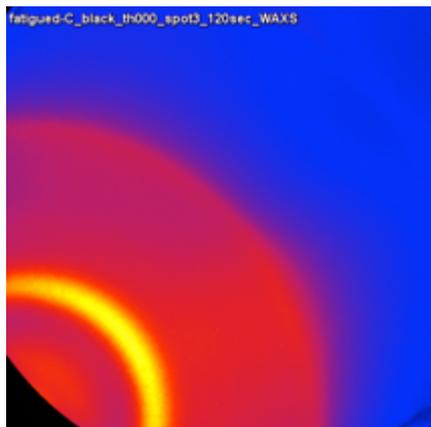
liquid like



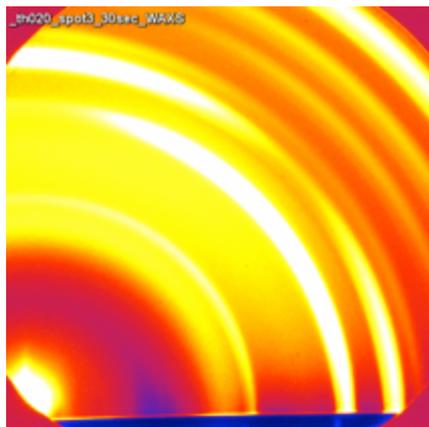
Interaction potential  
Form factor and Structure Factor

# X-ray Scattering from Structures

- Can easily infer amount of order:
  - Amorphous
  - Polycrystalline
  - Single crystal



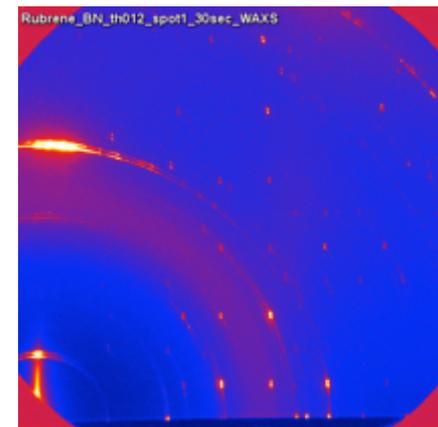
disordered



some ordering



oriented, textured

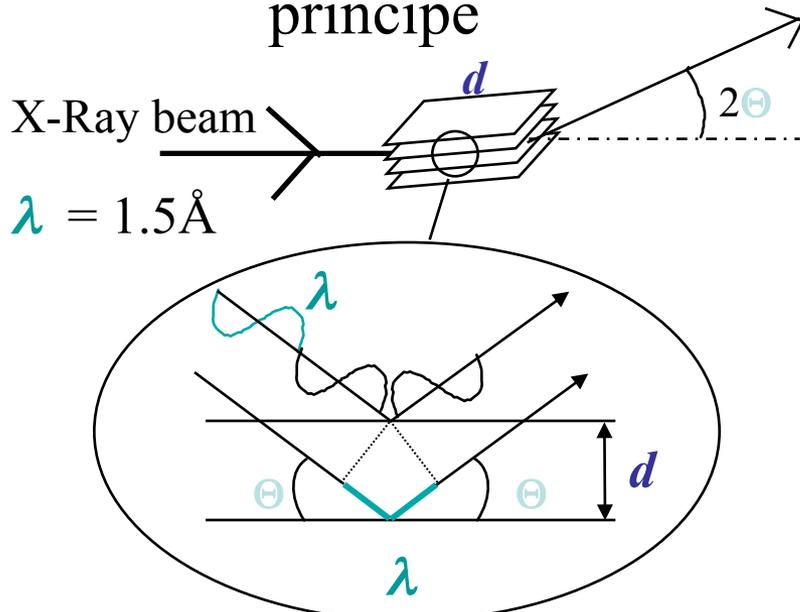


single crystal



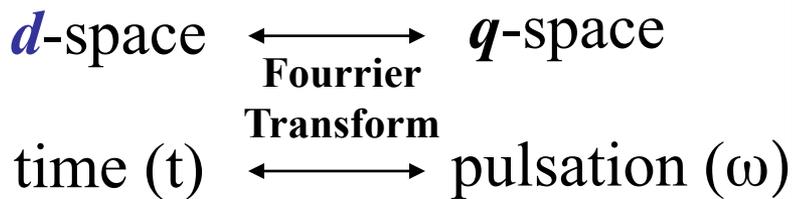
# X-Ray diffraction: Revealing order at scales 1-1000Å

principe

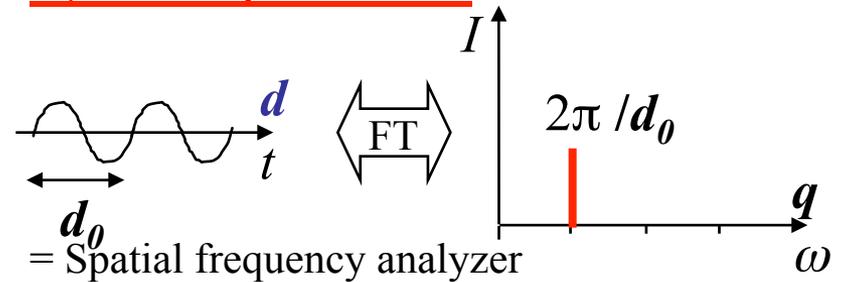


Bragg  $\Rightarrow n\lambda = 2 d \sin\Theta$

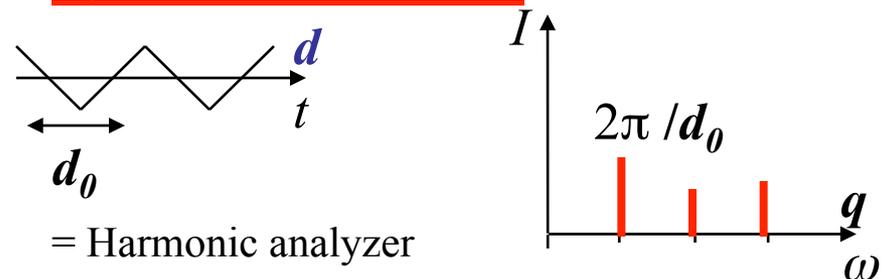
$d \cdot q = 2\pi$



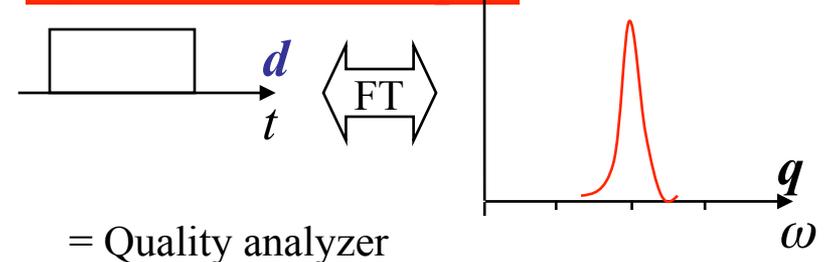
## 1) Peak positions



## 2) Peak intensities



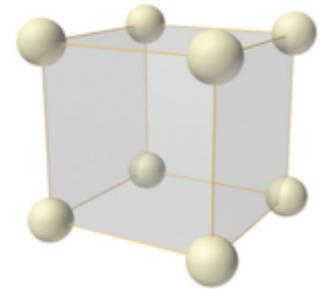
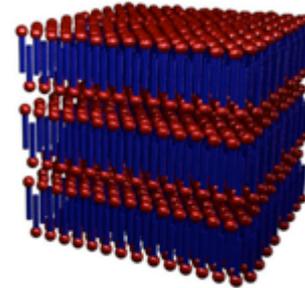
## 3) Peak line shapes



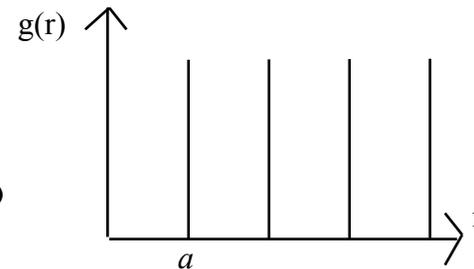
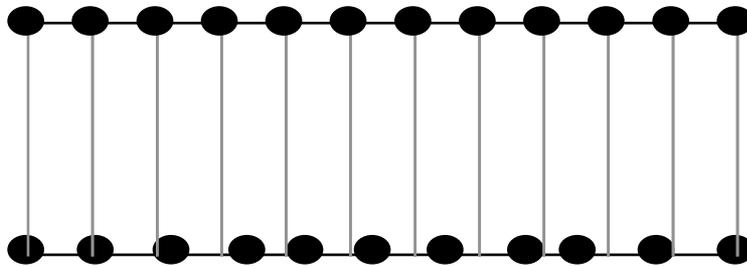
# Long and Short range Positional Order

Diffractions peak position ratios for common lattices

- Lamellar symmetry: 1, 2, 3, 4, 5, ...
- Cubic symmetry: 1,  $\sqrt{2}$ ,  $\sqrt{3}$ , 2,  $\sqrt{5}$ , ...
- Hexagonal symmetry: 1,  $\sqrt{3}$ , 2,  $\sqrt{7}$ , 3, ...

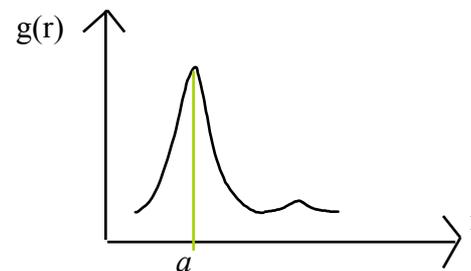


Solid



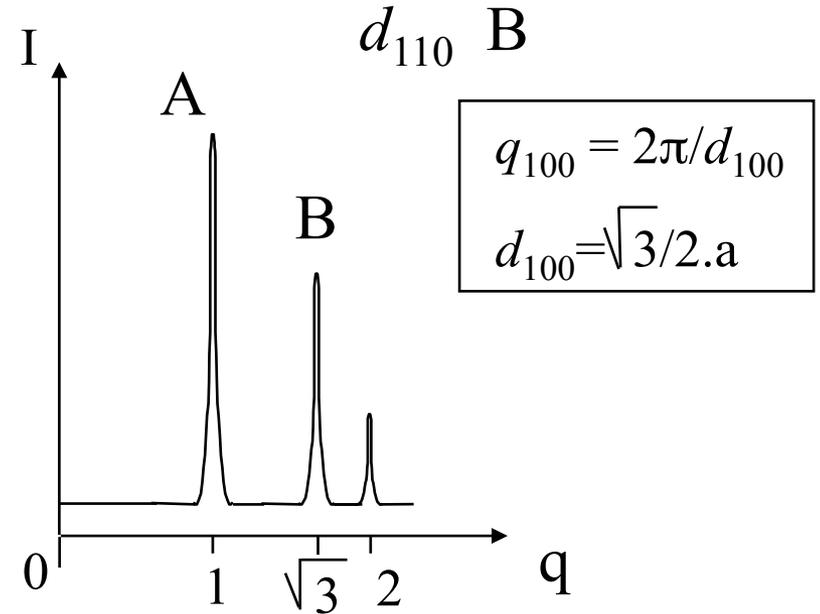
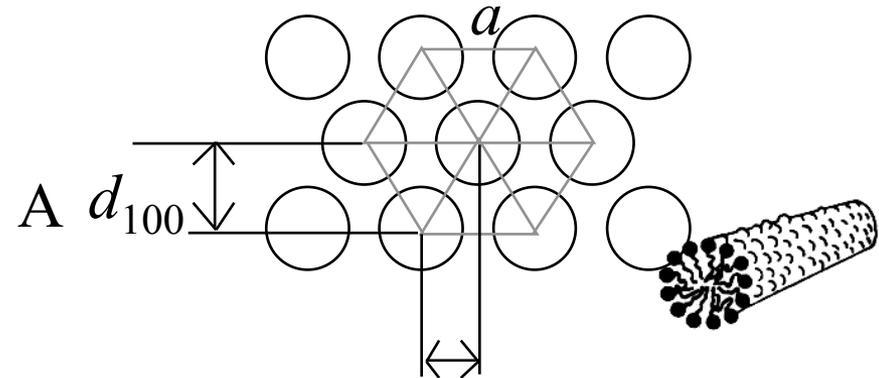
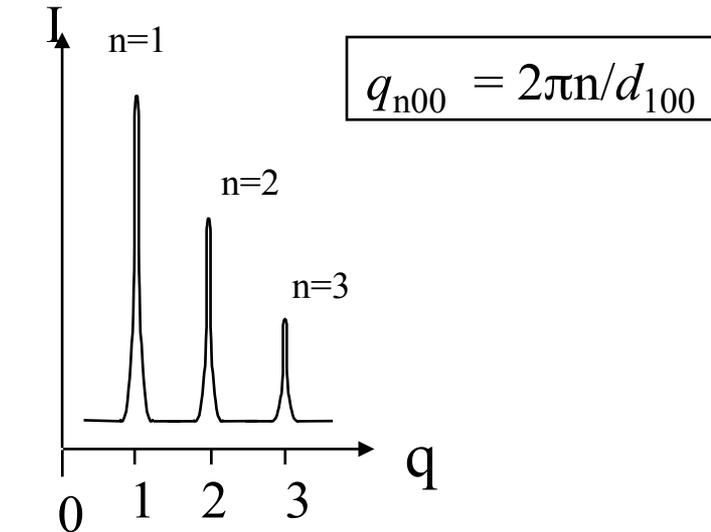
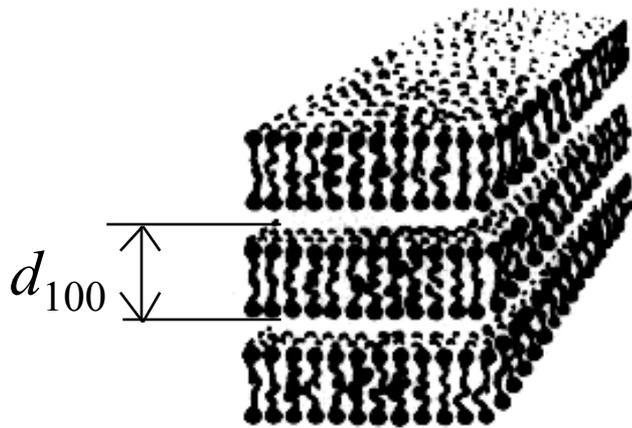
Long  
Range  
Order

Liquid



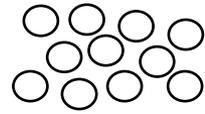
Short  
Range  
Order

# Lamellar and Columnar Mesophases: X-ray patterns

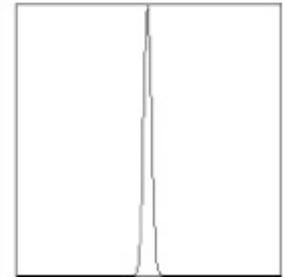
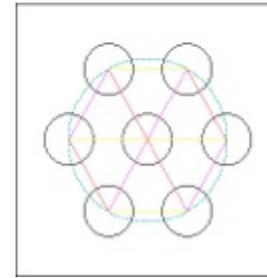
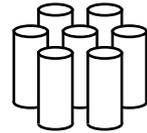
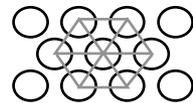


# 2D Lattice Distortion

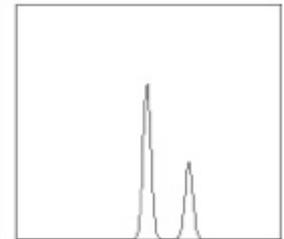
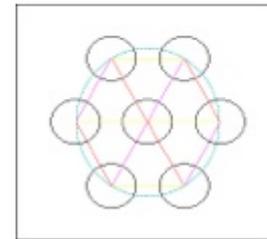
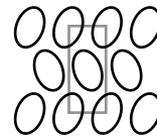
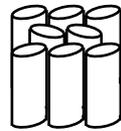
Molten



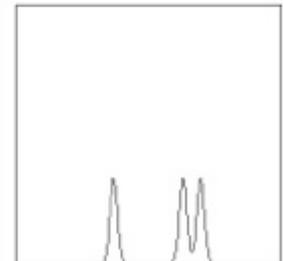
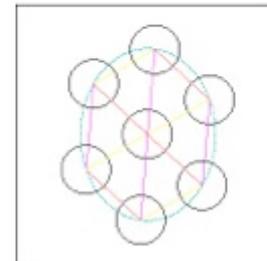
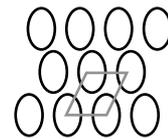
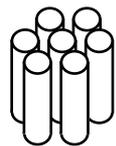
Hexagonal



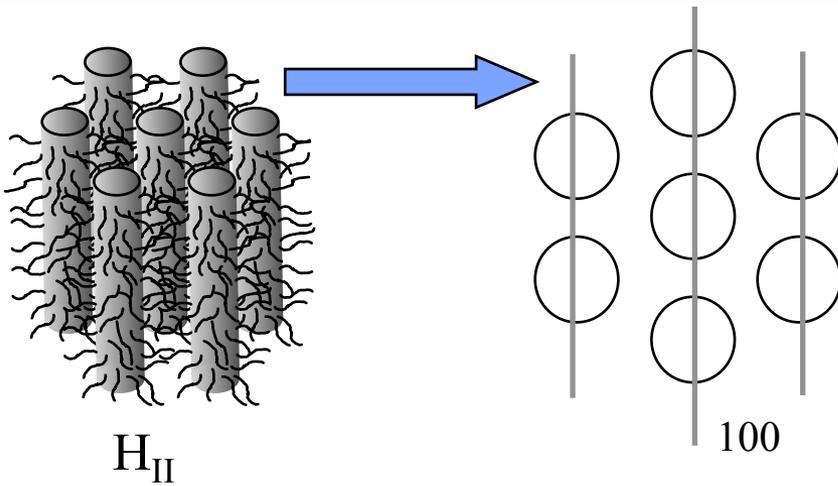
Orthorhombic



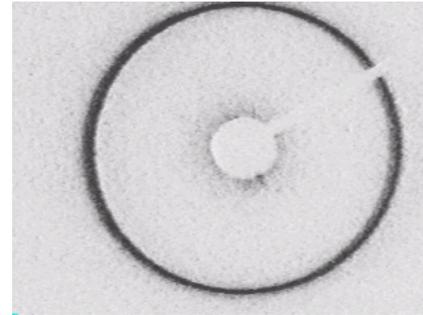
Monoclinic



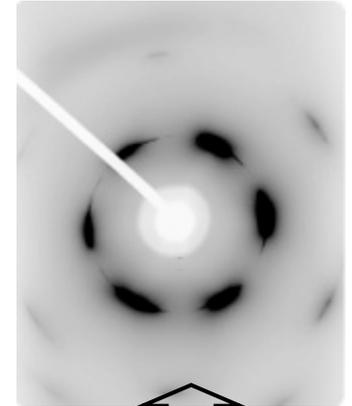
# Powder sample



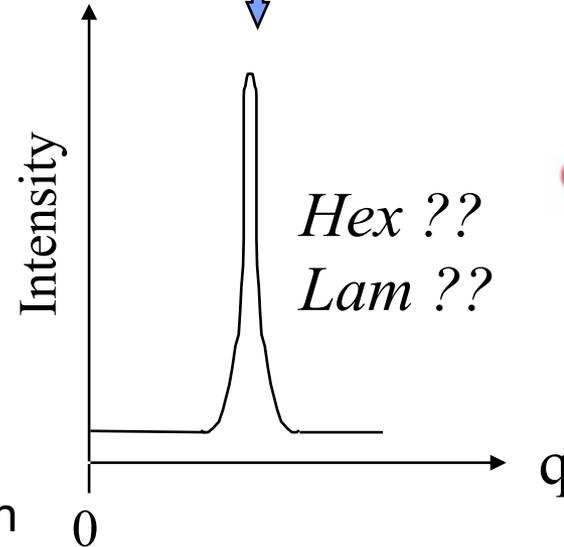
Many small single crystalline domains



Single Crystal



Azimuthal Integration



FT



Scherrer formula for estimation of domain sizes

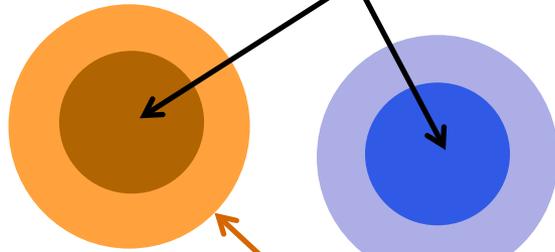
$$D = \frac{K\lambda}{\beta \cos \theta}$$

Resolution corrected FWHM

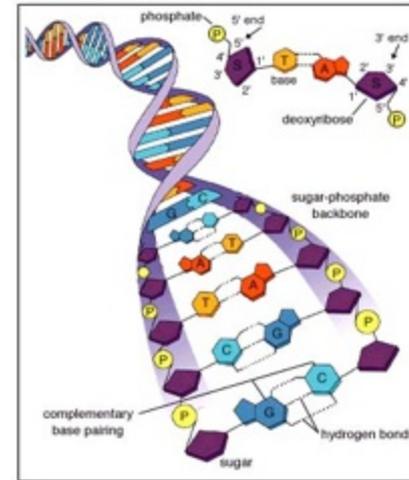
K is ~1, depends on domain shape and strain

# Assembly of Nanoparticle Systems with DNA

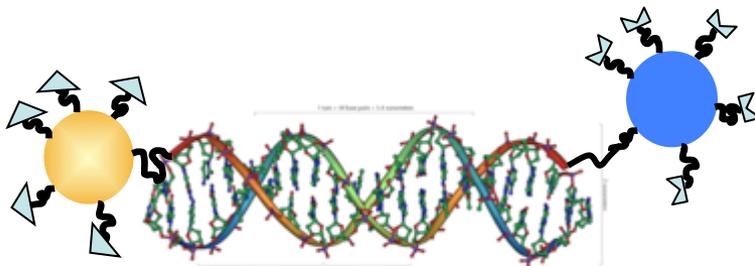
Particle's cores



Shells from DNA



[http://www.mhhe.com/biosci/esp/2001\\_gbio/folder\\_structure/ge/m4/s1/](http://www.mhhe.com/biosci/esp/2001_gbio/folder_structure/ge/m4/s1/)

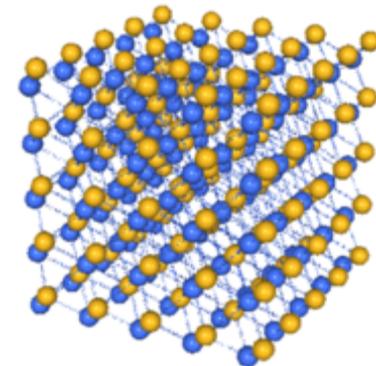


<http://en.wikipedia.org/>

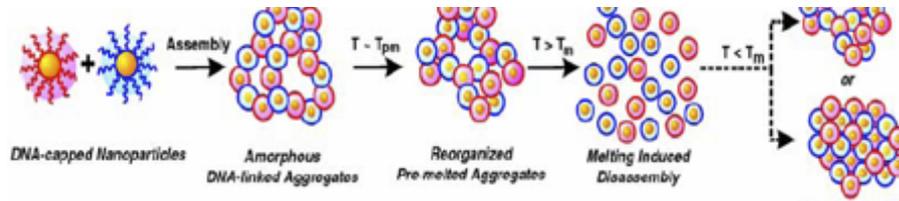
Challenges



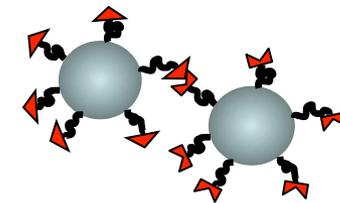
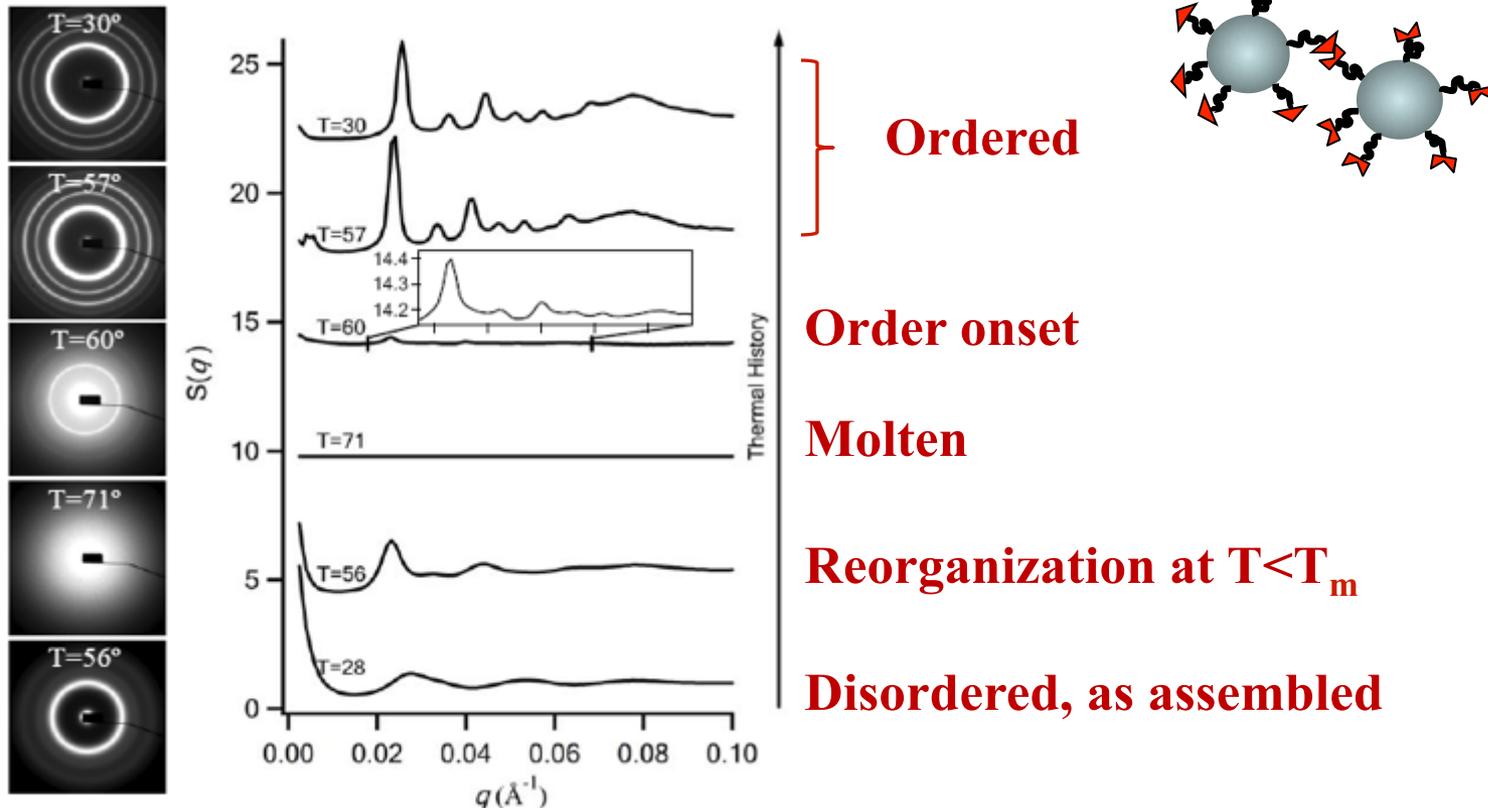
?



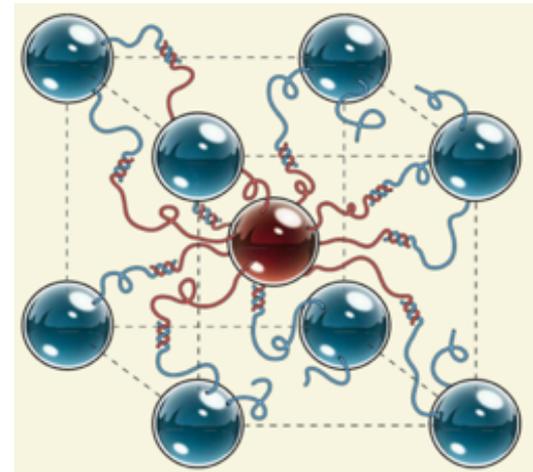
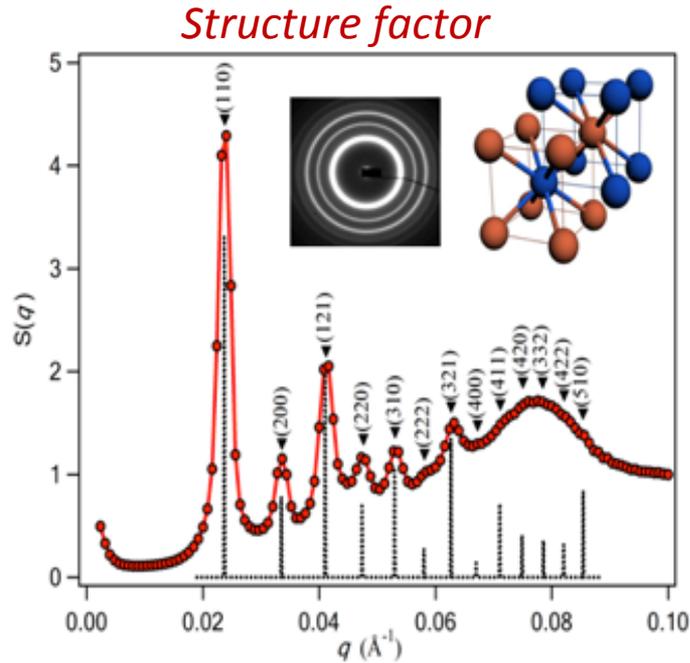
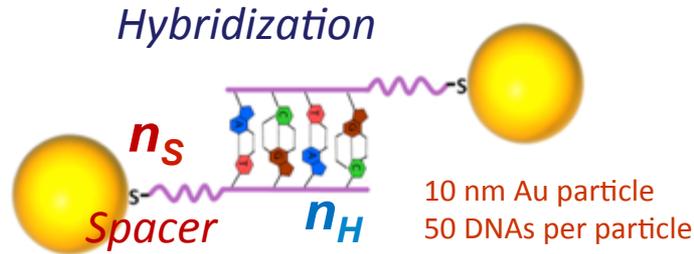
# DNA-guided 3D Ordering of Nanoparticles



- Even for the “right” potential assembly is locked in disordered metastable state



# DNA-guided 3D Ordering of Nanoparticles

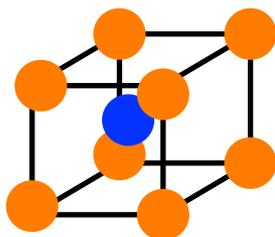


*body centered  
cubic (BCC)*

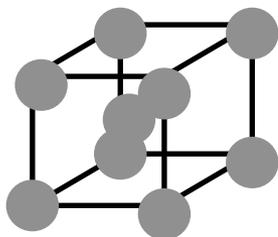
D. Nykypanchuk et al, Nature, 451, 549 (2008); H. Xiong et al, JACS (2008);  
H. Xiong et al, PRL (2009)

# Compositional Order in Binary Systems

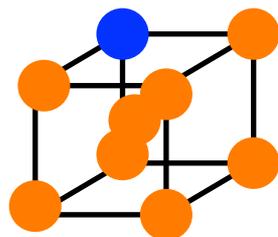
CsCl structure



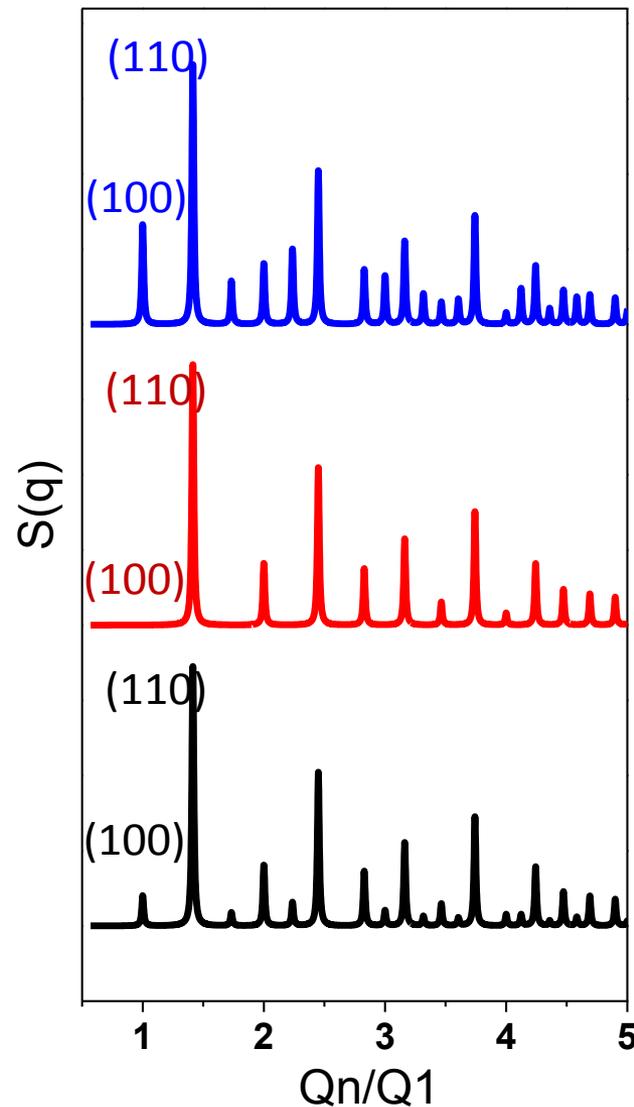
Different electron density



Positional Order -> Correlation length  $\xi$



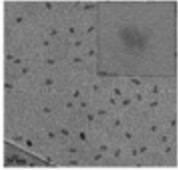
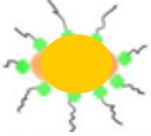
Compositional Order ?



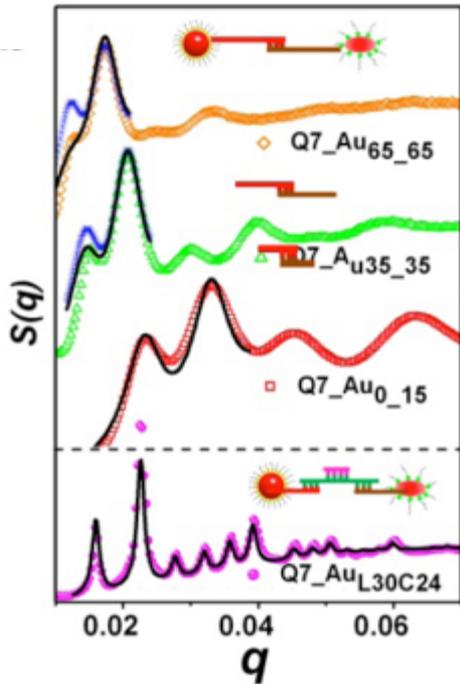
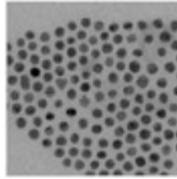
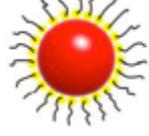
QD (CdTe)

Au

$f = 30$



$f = 50$



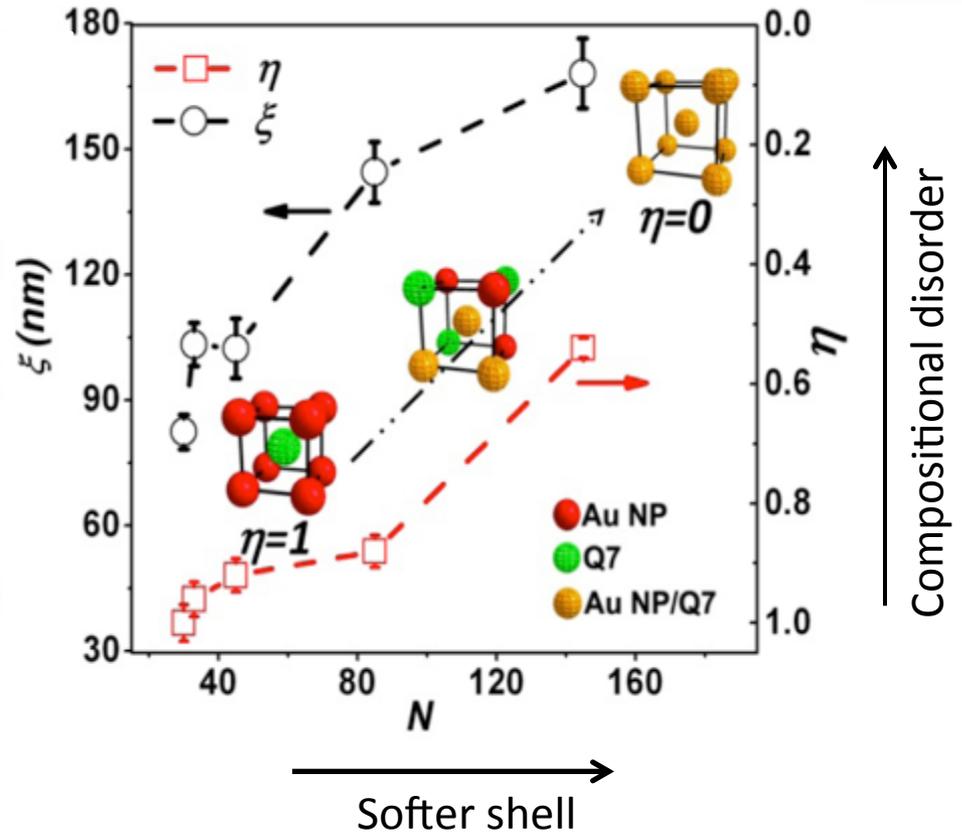
Longer ssDNA

**Compositional disorder  $\eta = (r_A - F_A)(1 - F_A)$**

$r_A$  : fraction of A sites occupied by A particles

$F_A$  : fraction of A particles in the lattice

Binary QD and Au

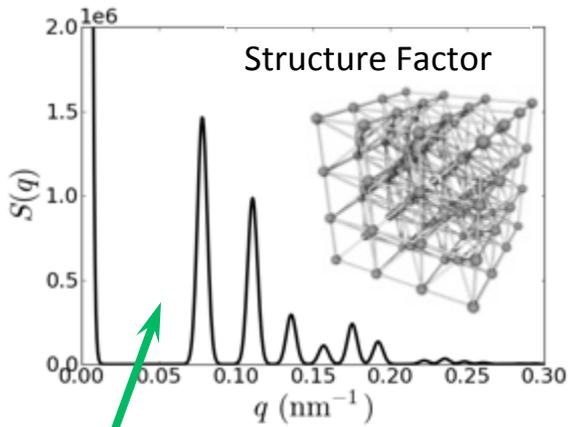


Compositional disorder

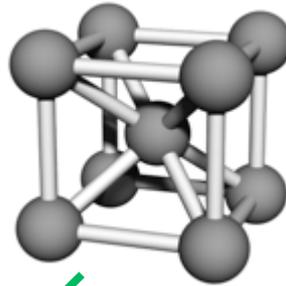
Softer shell

Compositional disorder continuously increases with the ssDNA shell thickness

# Scattering from Nanoparticle Lattices

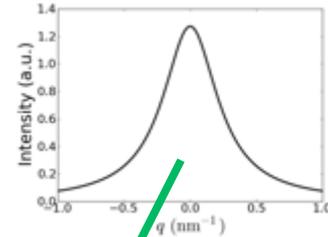


Lattice Unit Cell



Plane Wave

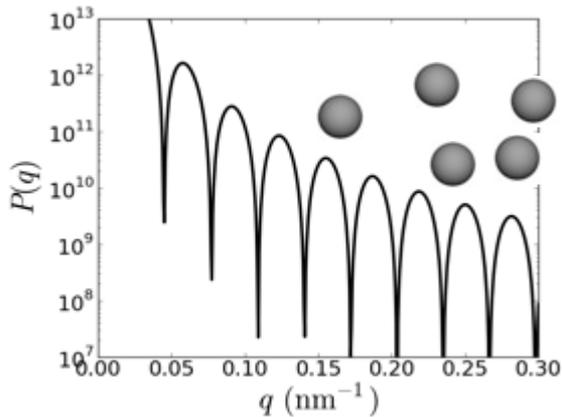
Peak Shape



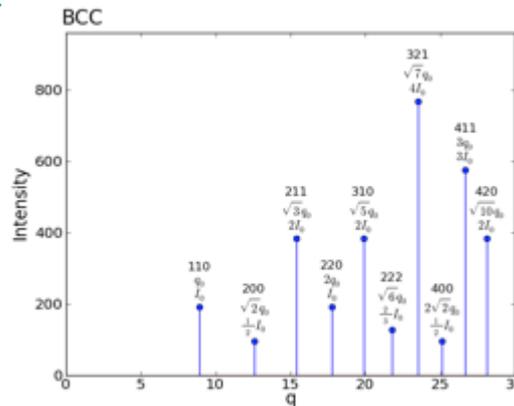
Debye-Waller (thermal disorder)

$$S(q) = \frac{c}{n} \sum_{hkl}^{m_{hkl}} \left| \sum_{j=1}^{n_c} F_j(M \cdot a_{hkl}) e^{2\pi i(x_j h + y_j k + z_j l)} \right|^2 e^{-\sigma_D^2 q_{hkl}^2 a^2} L_{hkl}(a - a_{hkl})$$

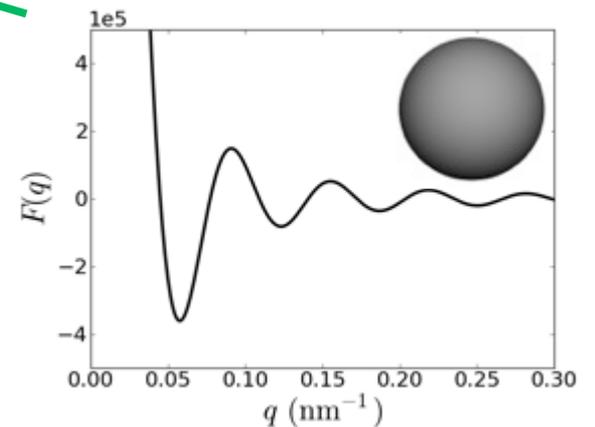
Isotropic Form Factor



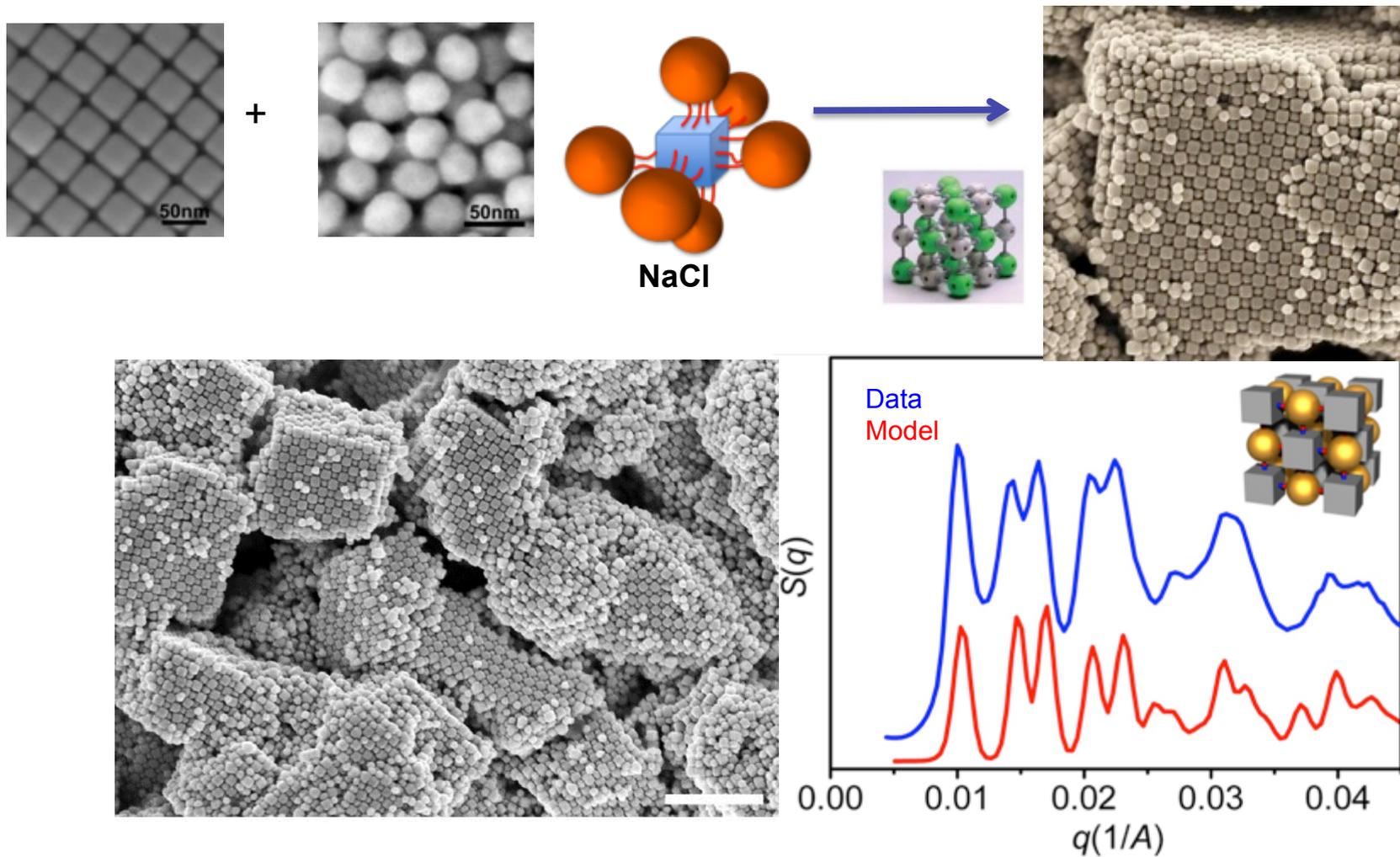
Reciprocal-space Peaks



Particle Form Factor



# Cube-Directed Assembly of Spheres



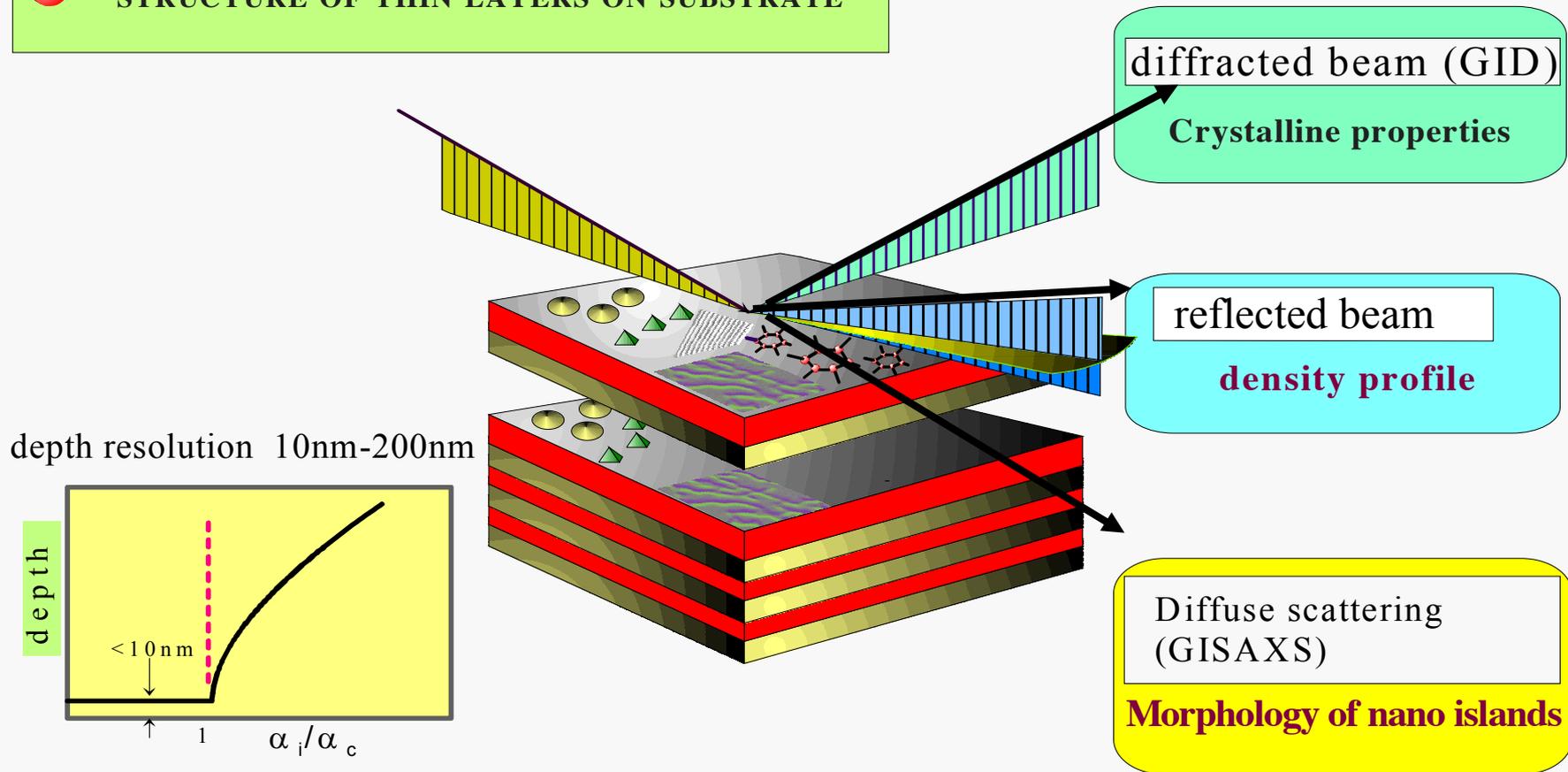
# Outline

- ✓ Why Scattering and its Basics
- ✓ Small Angle X-ray Scattering (SAXS)
  - ✓ Scattering from Individual Objects
  - ✓ Scattering from Lattices and Complex Organizations
- ✓ **Surface Scattering**
  - ✓ **Grazing Incidence Small Angle X-ray Scattering (GISAXS)**
  - ✓ X-ray Reflectivity (XRR)
- ✓ Instrumentation and data processing
- ✓ Examples of Applications for Material Studies (through the talk)

# X-RAY METHODS AT GRAZING INCIDENCE

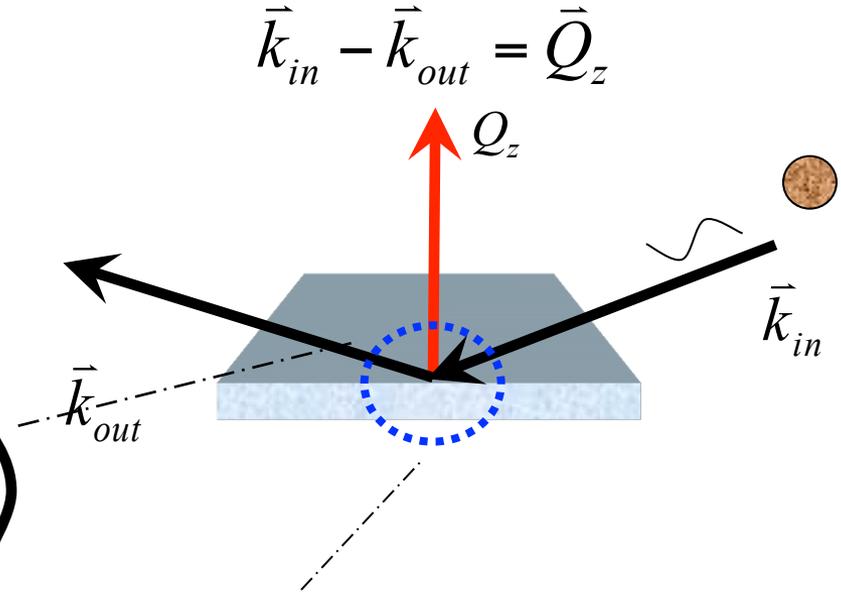
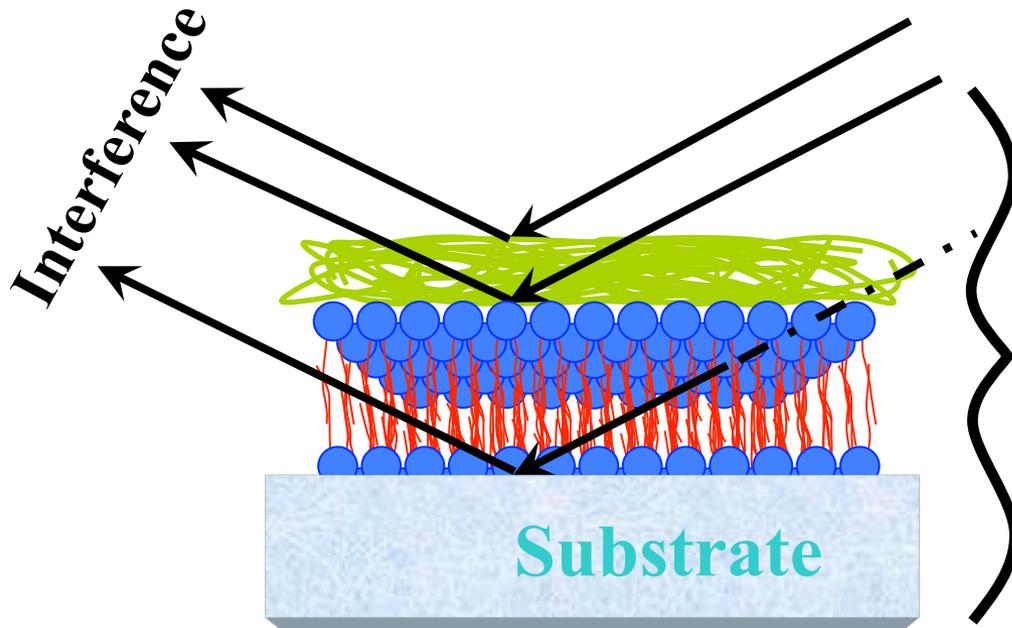


## STRUCTURE OF THIN LAYERS ON SUBSTRATE



# Reflectometry

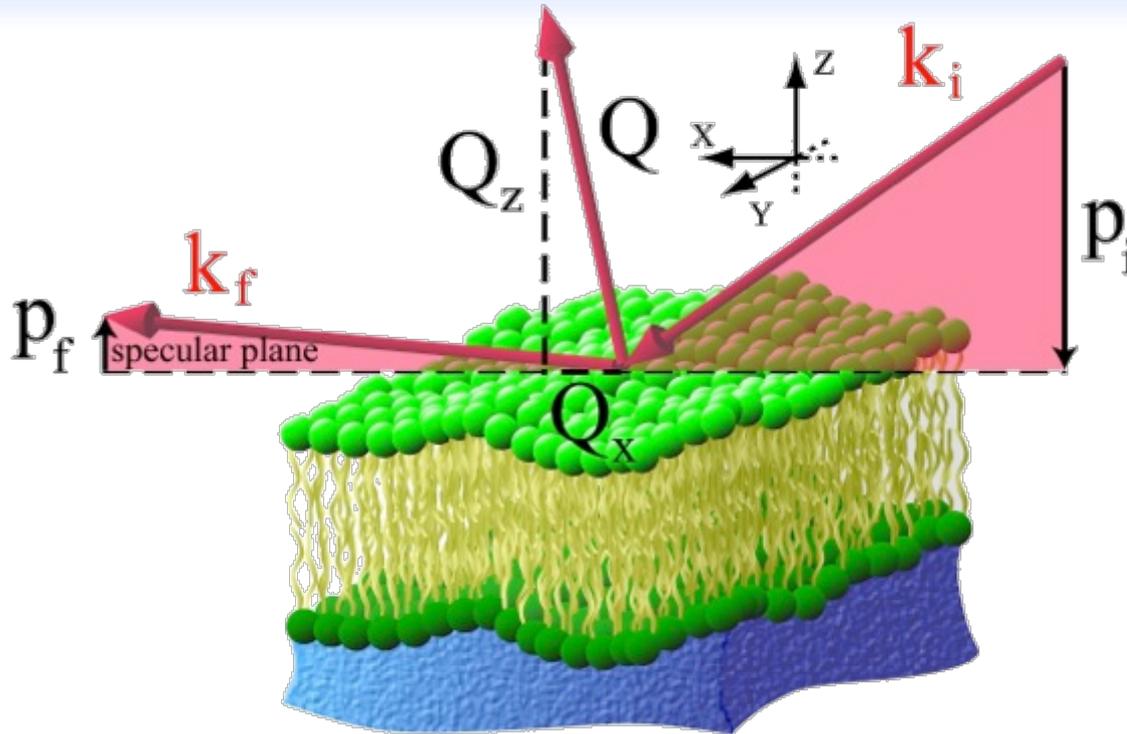
- X-rays are incident at low angles
- Constructive / Destructive interference
- Measure Reflectivity ( $I/I_0$ ) vs  $Q_z$
- Penetration through material



$$\vec{k}_{in} - \vec{k}_{out} = \vec{Q}_z$$

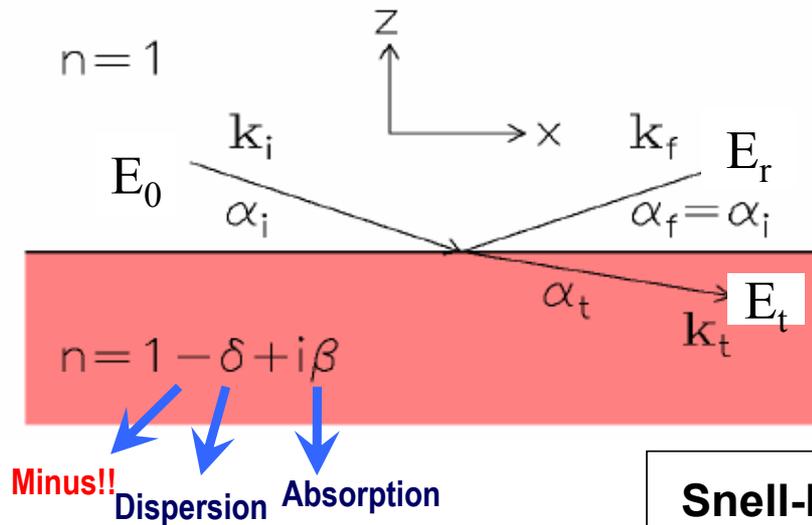
- From Reflectivity vs.  $Q_z$ 
  - Thickness (Angstrom resolution)
  - Roughness
  - Density
  - Surface coverage

# Off-specular scattering



- Probes in-plane structure on surface and interfaces (with  $Q_x$ )
- In-plane length-scales (correlations) from  $\sim 100$  nm to  $>40$   $\mu$ m
- Roughness correlation from layer to layer
- Use of Distorted Wave Born Approximation to model 2D map

# Reflection and refraction – Perfect surface



$$\delta = \frac{\lambda^2}{2\pi} r_0 \rho \approx 10^{-4} \cdot 10^{-6}$$

$$\beta = \frac{\lambda}{4\pi} \mu \approx 10^{-6} \cdot 10^{-9}$$

**Snell-Descartes law:**  $\cos \alpha_i = n \cos \alpha_t$

transmitted wave only if  $\cos(\alpha_t) \leq 1$ , i.e.  $\alpha_i \geq \alpha_c$

If  $\alpha_i \leq \alpha_c$ ,

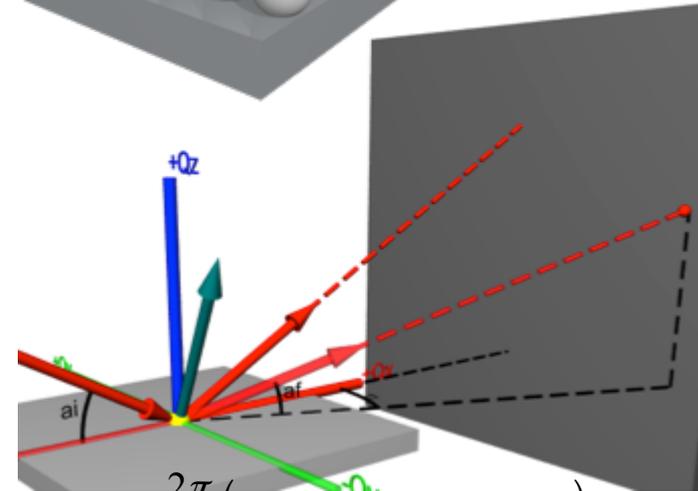
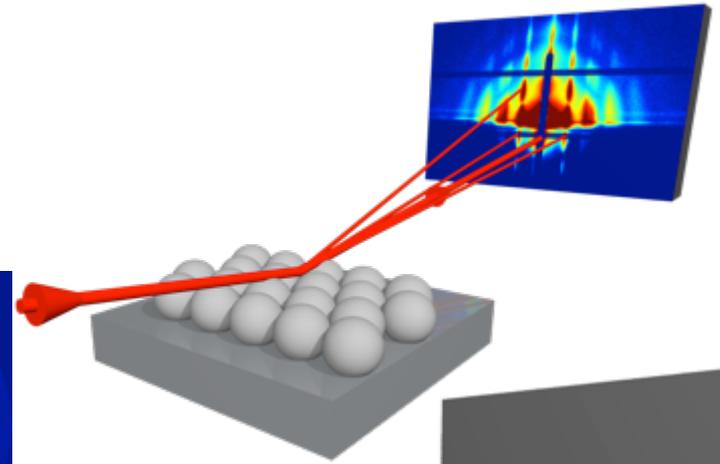
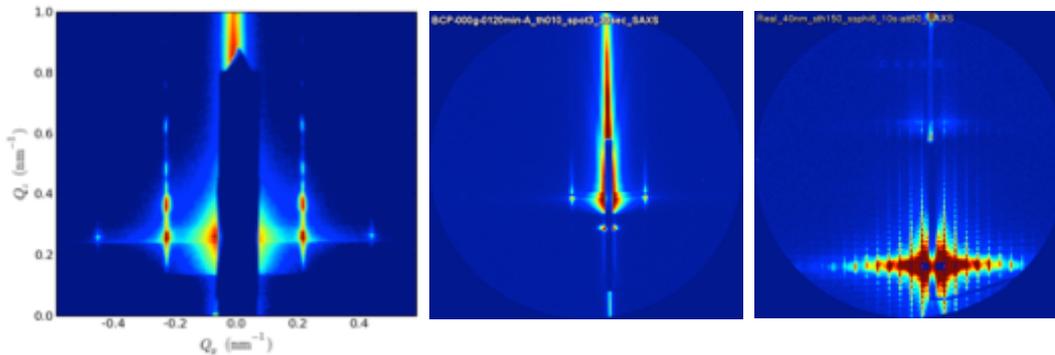
- Incident wave totally externally reflected.
- Transmitted wave exponentially damped with  $z$ .

$\alpha_c$  critical angle for total external reflection of X-rays

$$\alpha_c = \sqrt{2\delta} = \sqrt{\frac{r_0}{\pi}} \times \lambda \times \sqrt{\rho} \approx 0.1 \text{ to } 0.5^\circ$$

# Grazing Incidence Small Angle X-ray Scattering (GISAXS)

- Can look at surfaces exposed to liquid, vapor, etc.
- Can apply temperature, shear, electric-field, etc.



$$Q_x = \frac{2\pi}{\lambda} (\cos \theta_f \cos \alpha_f - \cos \alpha_i)$$

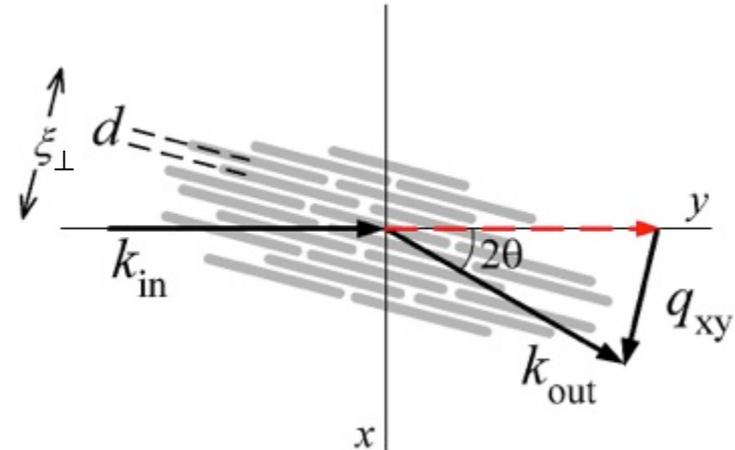
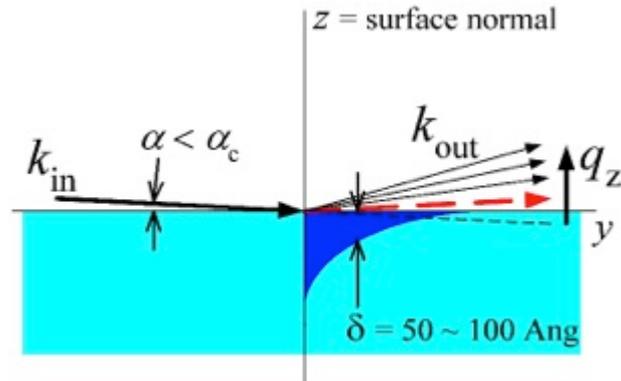
$$Q_y = \frac{2\pi}{\lambda} \sin \theta_f \cos \alpha_f$$

$$Q_z = \frac{2\pi}{\lambda} (\sin \alpha_f + \sin \alpha_i)$$

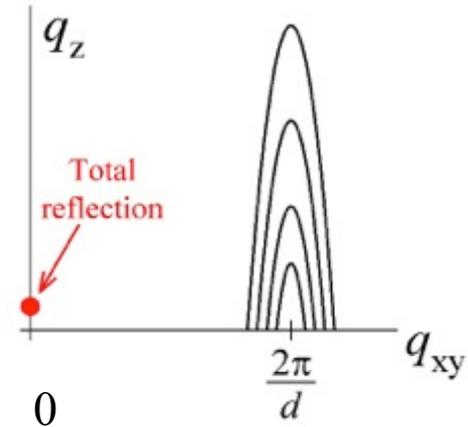
- Scattering measurement: symmetry, spacing, order, grain size, orientation
- Reflection angle provides limited depth-profiling
- Beam projection onto sample (~few mm and more) averages over large area
- Quantitative modeling of GISAXS (multiple reflections, etc.) is non-trivial

# Grazing Incidence Diffraction

## ⇒ Structure parallel to surface (2D diffraction)

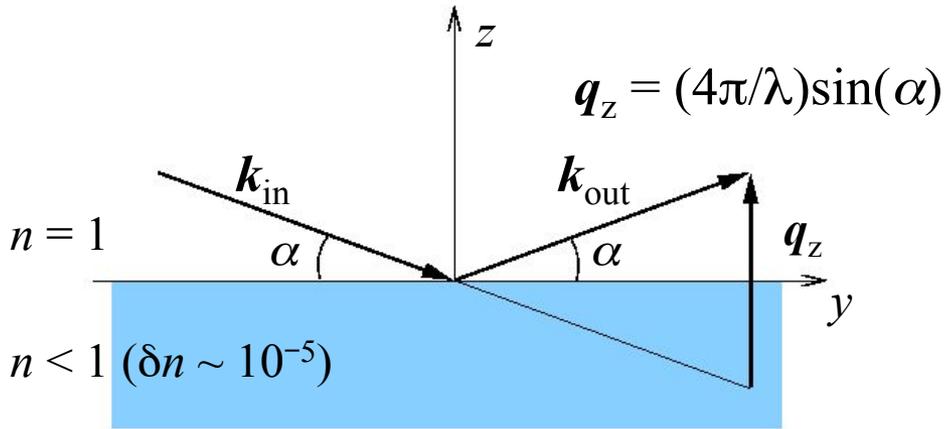


- Evanescence  
⇒ Scattering mostly from surface
- Lateral periodicity  $d \Rightarrow$  Peak at  $q_{xy} = 2\pi/d$
- In-plane structure of 2D lattice is determined from the diffraction peaks, similar to 3D
- Lateral correlation length  $\xi_{\perp}$   
⇒ Resolution-corrected  $\text{HWHM}\{q_{xy}\} \sim 1/\xi_{\perp}$
- $q_z$ -dependence (e.g., Bragg rods):  
⇒ Molecular form factor, molecular tilt, etc.



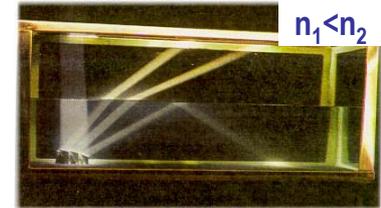
# X-ray Specular Reflectivity

⇒ Structure normal to surface

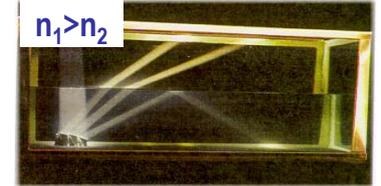


## X-Ray Reflectivity: Principle

Visible Light Reflectivity:  $\frac{n_1}{n_2}$   
 $n_2 > 1$



X-Ray Reflectivity:  $\frac{n_1}{n_2}$   
 $n_2 < 1$



adapted M. Tolan Univ. Dortmund

- Ideally sharp and flat interface: ⇒ **Fresnel reflectivity**

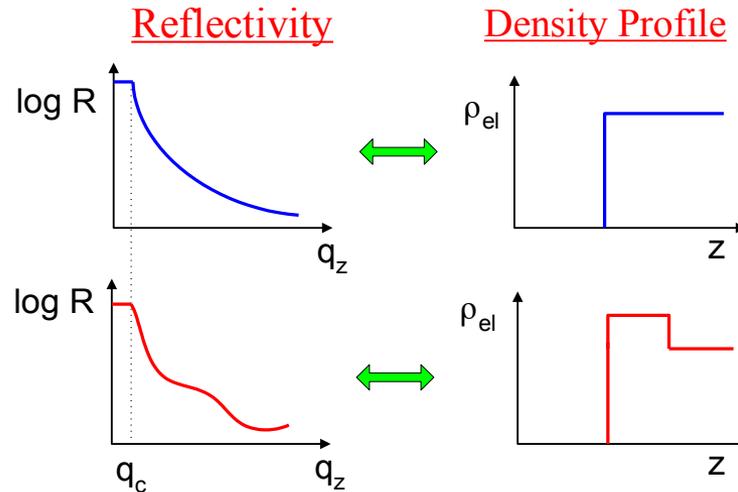
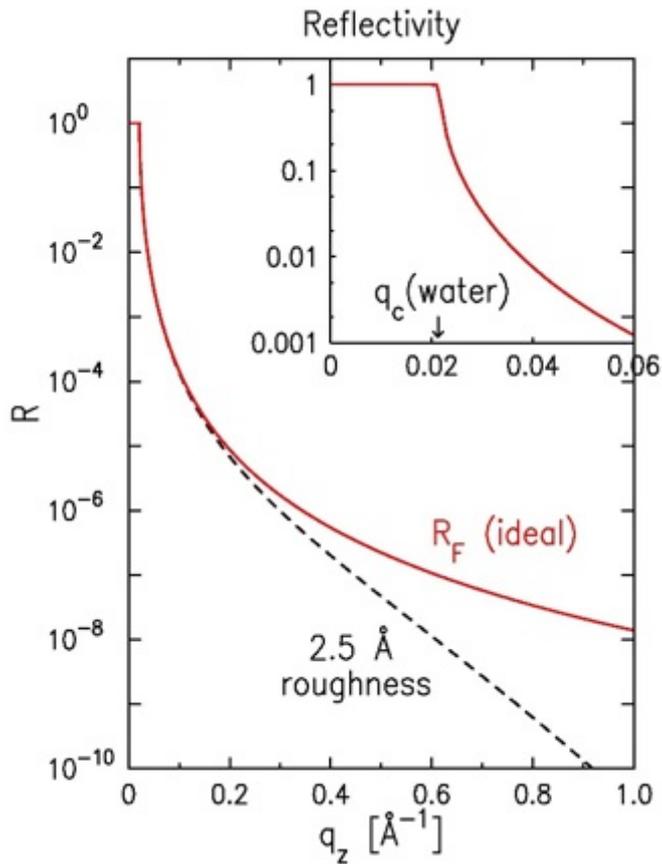
$$R_F(q_z) = \left| \frac{q_z - \sqrt{q_z^2 - q_c^2}}{q_z + \sqrt{q_z^2 - q_c^2}} \right|^2 = \begin{cases} 1 & \text{for } q_z < q_c \\ \sim (q_c/2q_z)^4 & \text{for } q_z \gg q_c \end{cases}$$

- Real interface (roughness, diffuseness, layers, etc.):

$$R(q_z) \approx R_F(q_z) \left| \int dz \frac{d}{dz} \left[ \frac{\langle \rho(z) \rangle}{\rho_\infty} \right] \exp(iq_z z) \right|^2$$

# X-ray Specular Reflectivity

⇒ Structure normal to surface

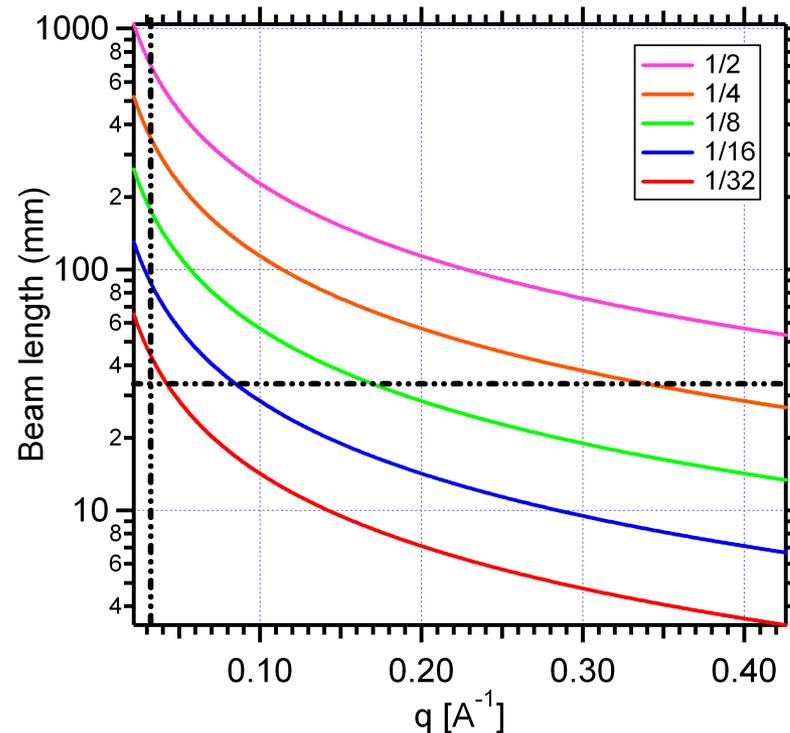
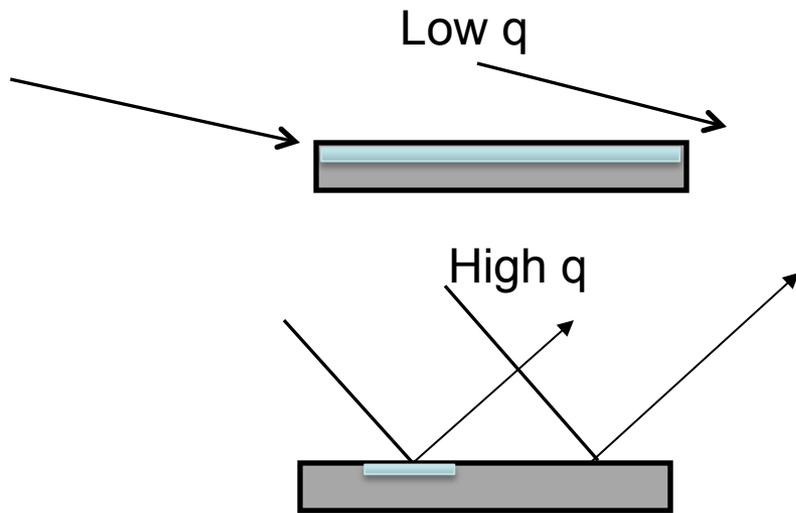


Modeling is needed to reconstruct the electron density profile

- XR: low incident angles ( $<5^\circ$ )
- Relatively large surface areas are probed
- XR: Electron density profile normal to the surface
- Large dynamical range of profile measurements: thickness 0.1- hundred nm, relative contrast  $\sim$  few %
- Liquid surfaces can be investigated!

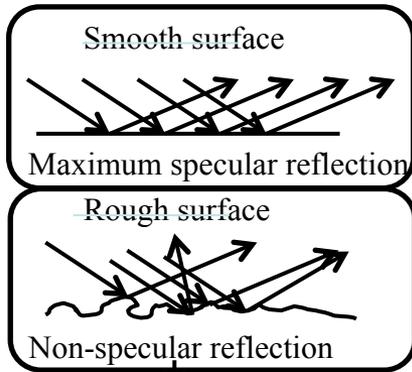
# Features - Footprint effect

In the regime of total external reflection, some intensity is lost as the footprint on the surface is too large



Foot print depends on beam width & sample geometry

# What affects reflectivity?

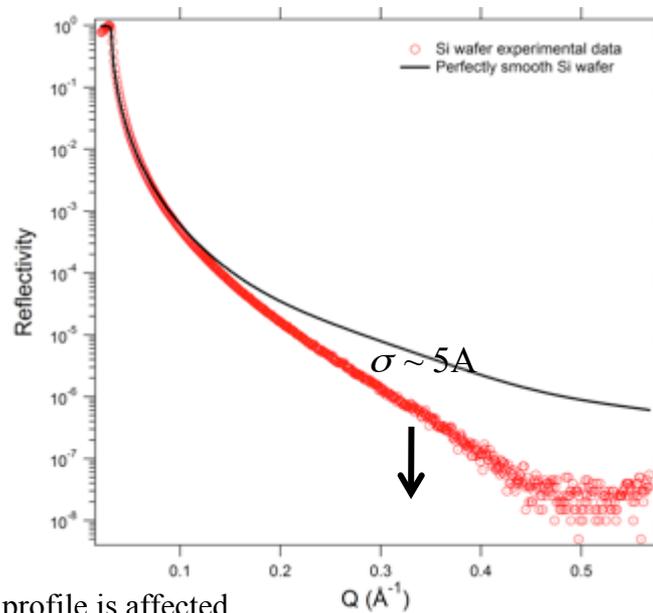


Loss of intensity and sharpness

Effect of roughness depends on coherence length  $l_c$

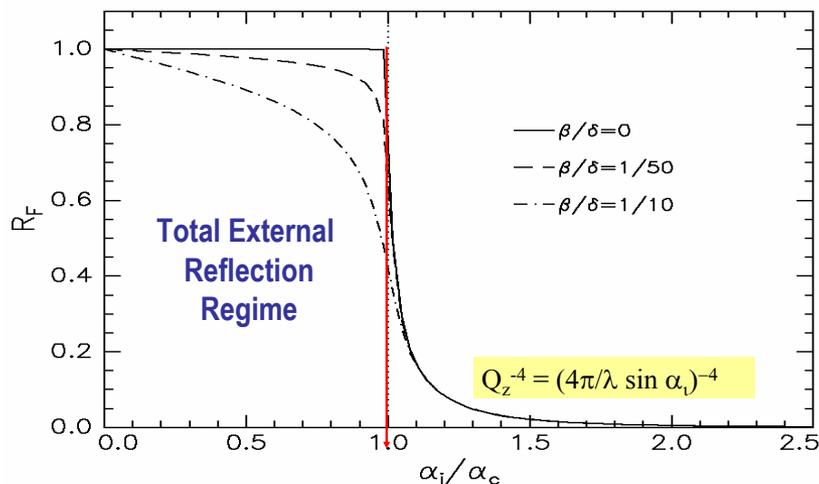
$$l_c = \frac{\lambda}{2\alpha}$$

Only if roughness features  $< l_c$ , reflectivity profile is affected



Large  $Q$ :  
roughness

Small (very)  $Q$ :  
Absorption effect  
and footprint



# X-ray reflectivity for layered system

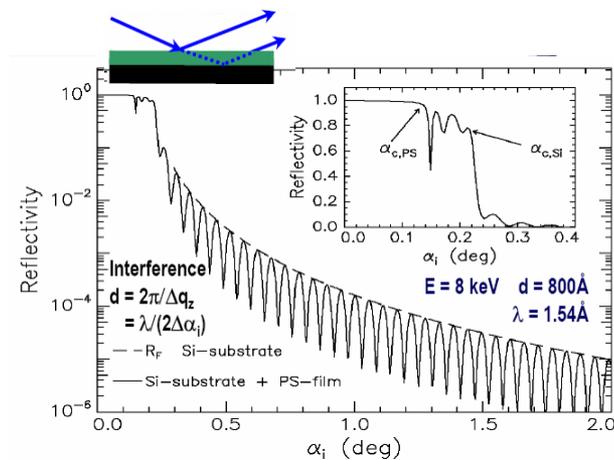
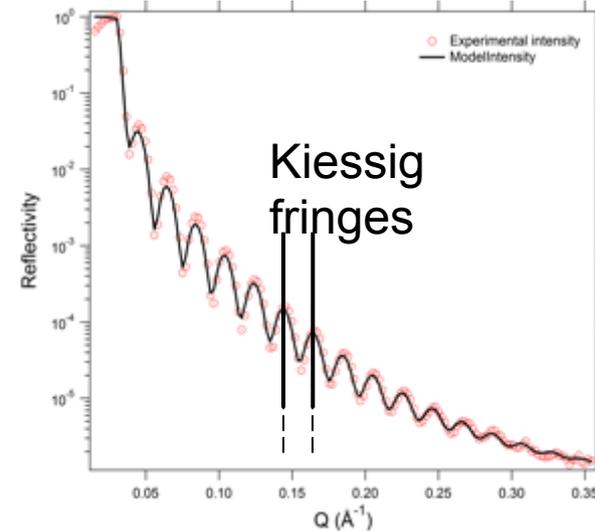
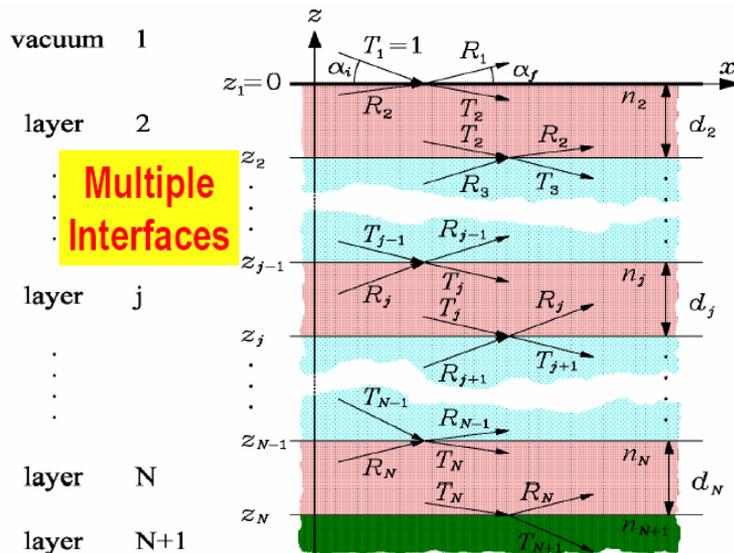
## Simple estimation of film thickness

Fringes with uniform spacing  
 Thickness of the layer :

$$t = \frac{2\pi}{\Delta q_z}$$

## Multilayer films require detailed modeling accounting for each interface

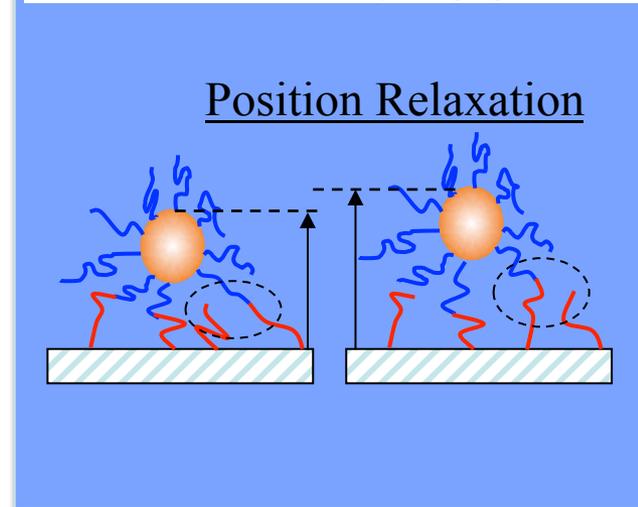
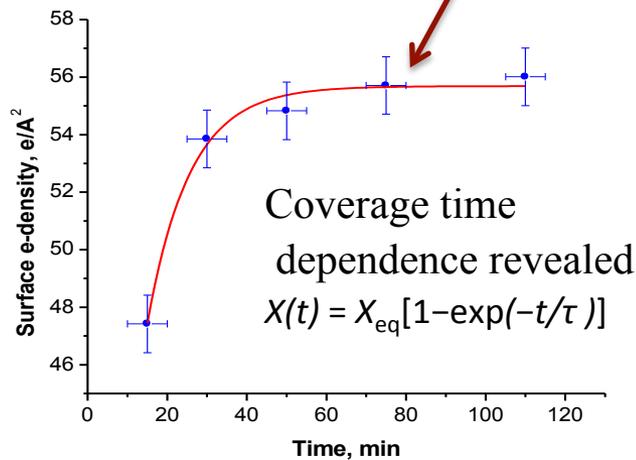
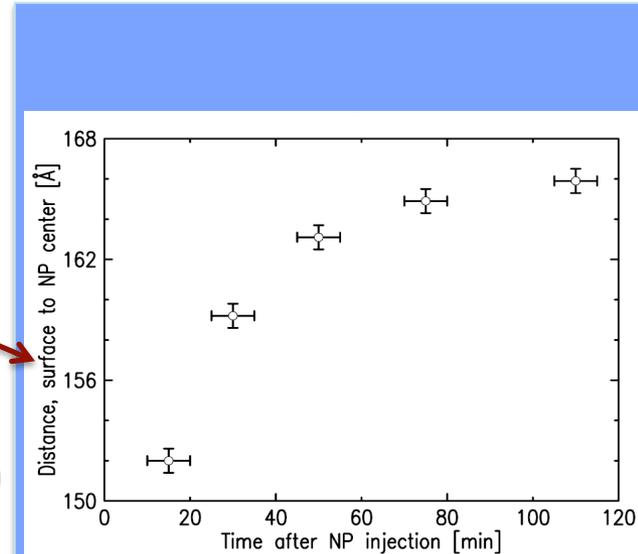
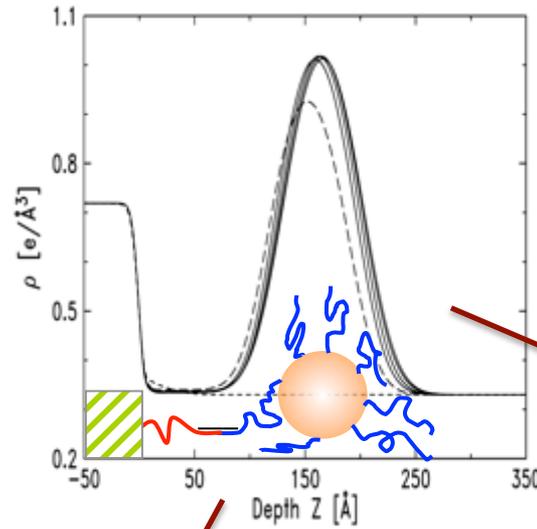
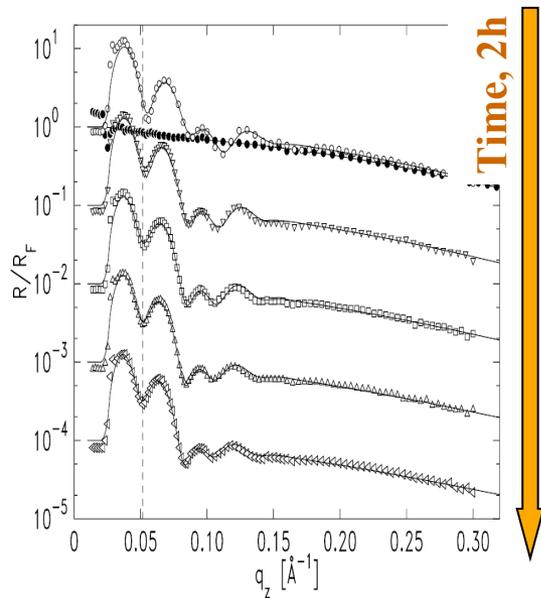
Multiple scattering (dynamical calculation)



→ Reflectivity used as an everyday laboratory tool to measure the thickness of layers deposited on a substrate

# Structure of 2D nanoparticle/DNA monolayer

High energy (19keV) X-ray probes normal surface structure in-situ at liquid-solid interface



# Outline

- ✓ Why Scattering and its Basics
- ✓ Small Angle X-ray Scattering (SAXS)
  - ✓ Scattering from Individual Objects
  - ✓ Scattering from Lattices and Complex Organizations
- ✓ Surface Scattering
  - ✓ Grazing Incidence Small Angle X-ray Scattering (GISAXS)
  - ✓ X-ray Reflectivity (XRR)
- ✓ **Instrumentation and data processing**
- ✓ Examples of Applications for Material Studies (through the talk)

# Synchrotron: NSLS II



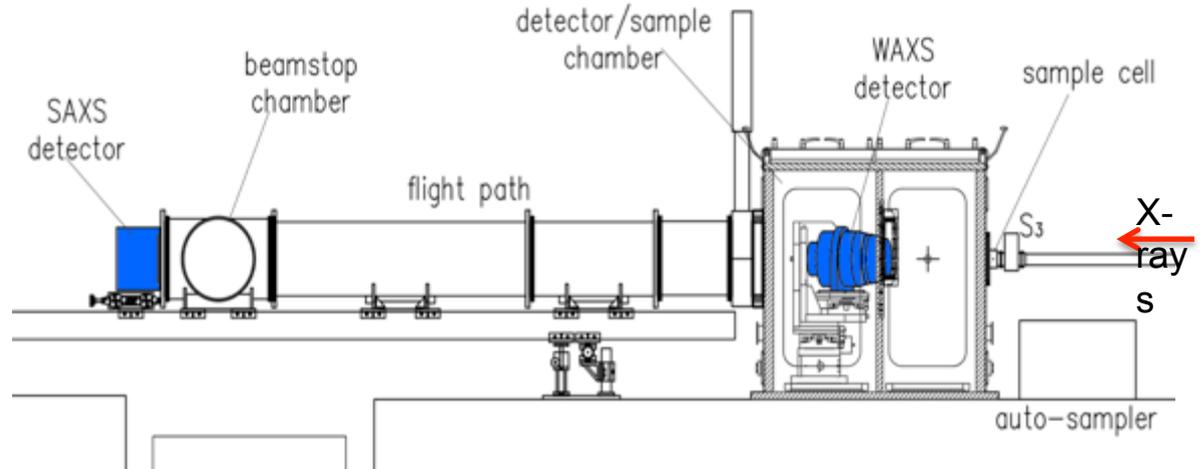
- NSLS II \$912M+
- 791 m circumference
- 58 beam ports
- 3 GeV, 500 mA

Coherent Hard X-ray Scattering (CHX) Beamline



- Each x-ray beam is  $\sim 10^{13}$  ph/s

# Experimental setup (X9 NSLS, *does not exist any more*)



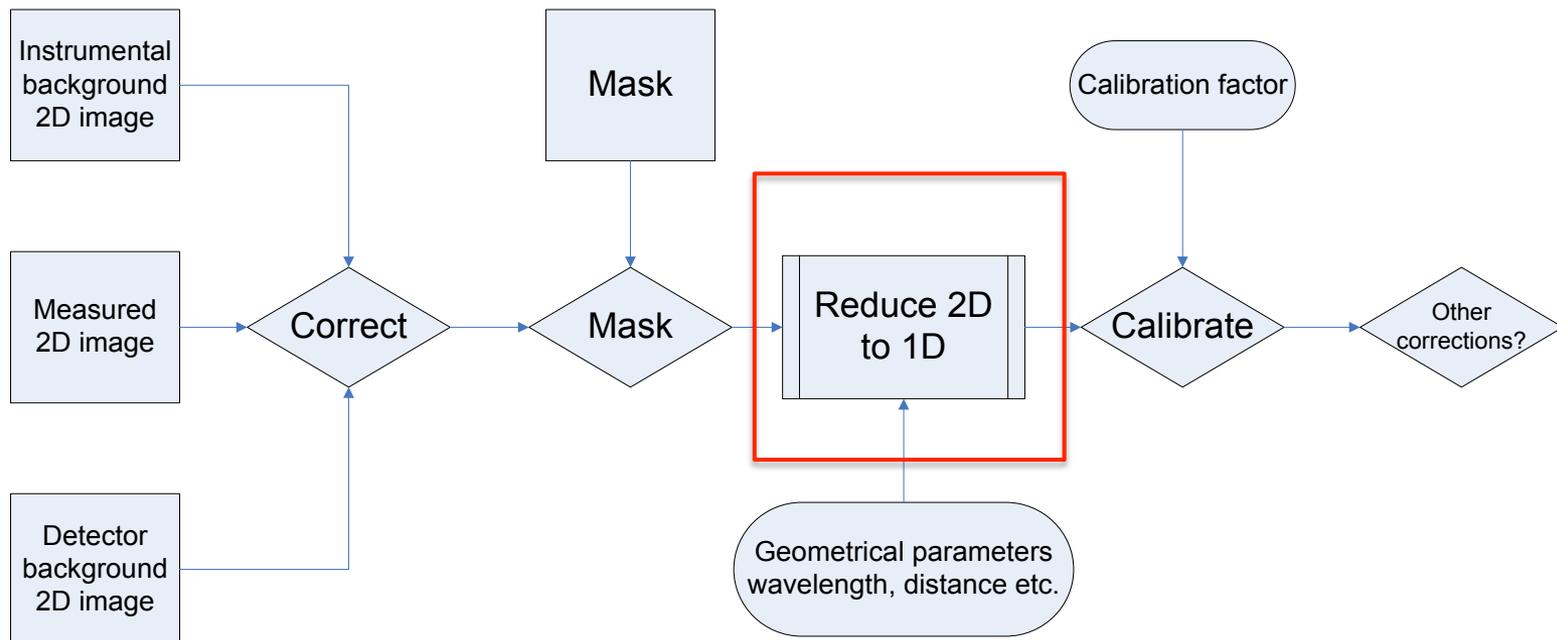
L. Yang, "Using an in-vacuum CCD detector for simultaneous small- and wide-angle scattering at beamline X9" J. Synch. Rad. 2013



- SAXS instruments in general use a series of slits to define beam size and minimize parasitic scattering
- A SAXS detector and an in-vacuum WAXS detector can provide a continuous reciprocal space coverage from molecular to micron sizes

# Following appropriate data reduction and calibration procedure

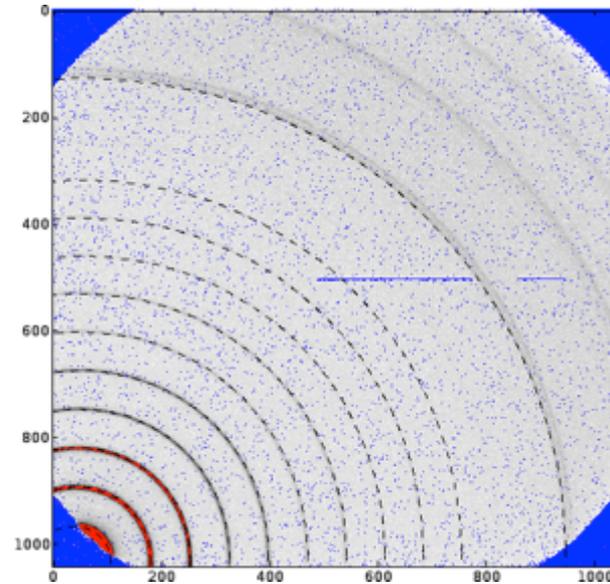
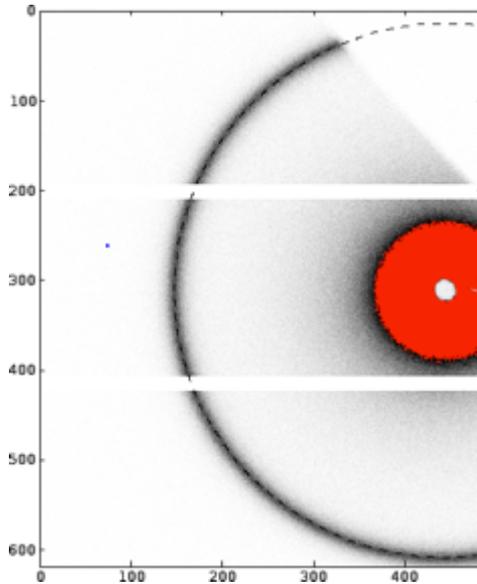
Number of different approaches, often specific to the used area detector & instrument design



$$\text{Data2D} = (\text{Sa2D} - \text{Dark2D}) - C * (\text{Bckg2D} - \text{Dark2D})$$

C ~ sample transmission, measurement times, incoming intensity etc.

# Parameters that define scattering geometry



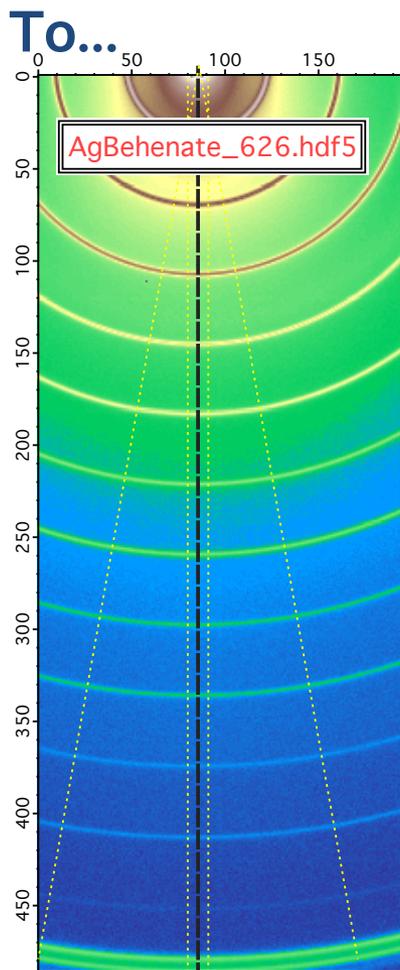
- Some area of 2D detector has to be masked for data reduction
- Calibration of distances and x-ray energy is crucial for the correct conversion to  $q$

$$q = \frac{4\pi}{\lambda} \sin \theta$$

```
es.wavelength = 0.886           # X-ray wavelength (Å)
es.bm_ctr_x = 425                # pixel position of the X-ray beam
es.bm_ctr_y = 480                #
es.ratioDw = 49.8               # this is the sample-to-detector distance divided by
                                # the width of the detector
es.det_orient = 0                # orientation of the detector
es.det_tilt = 0                  # 0, 0, 0 for the SAXS detector
es.det_phi = 0                  #
```

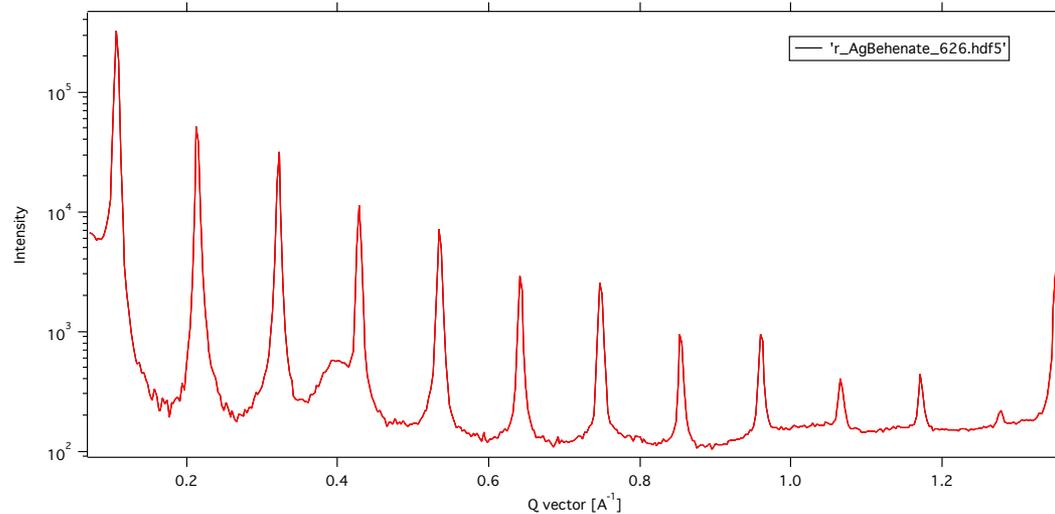
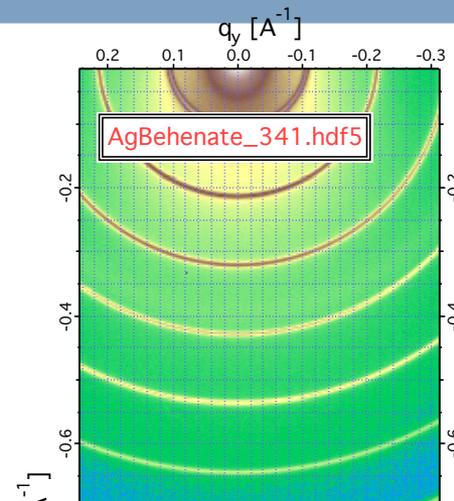
# 2D to 1D

$$Q = \frac{4\pi}{\lambda} \sin \theta$$



Convert this

Into this

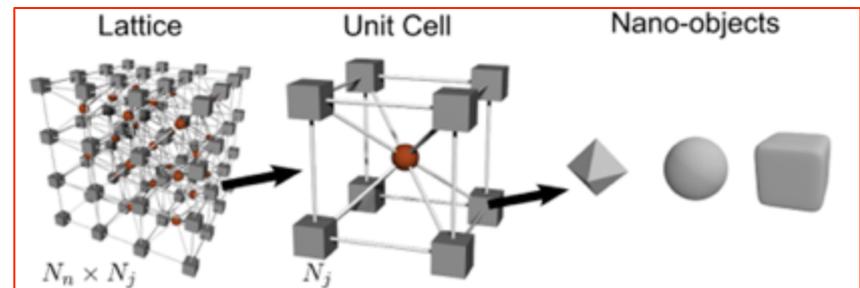
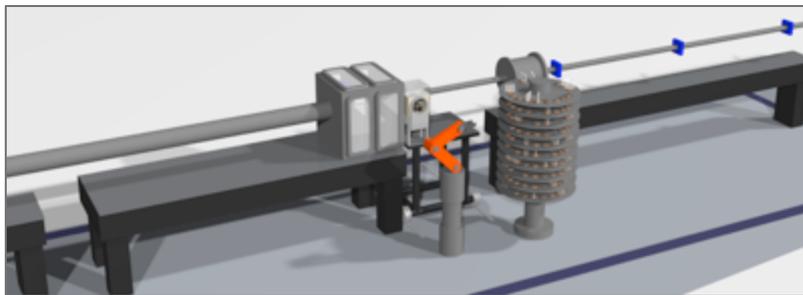
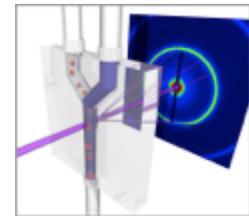
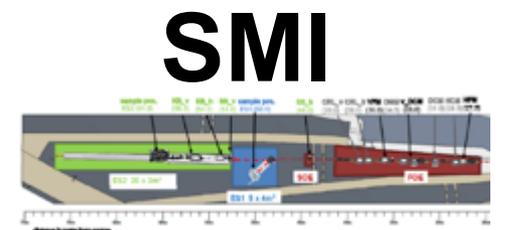
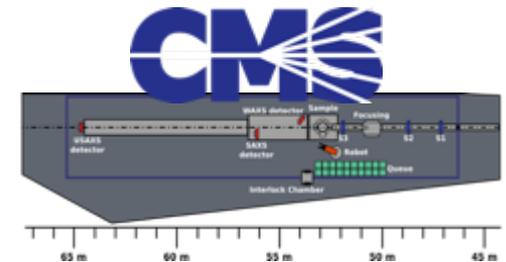


# Some of the tools to convert 2D data to 1D data

- Ideally – tools should be provided with instrument
  - Like ESRF (software is mostly specific for their data)
    - <http://www.sztucki.de/SAXSutilities/> (Michael Sztucki, processing of SAXS data)
    - <http://www.esrf.eu/computing/scientific/SAXS/> (Peter Boesecke, manipulation of 2D data)
- **Fit2D** - <http://www.esrf.fr/computing/scientific/FIT2D/> free, in use for very long time (= debugged), large user base, very capable
  - However, not very user friendly and cumbersome for data analysis of large number of data sets – need to learn how to write scripts.
  - Ideal for processing large sets of samples (scripting).
  - Available for many platforms
- **Datasqueeze** - <http://www.datasqueezesoftware.com/>, \$100/\$50 for user license, Windows/Linux/MacOS.
- **Nika** – Igor Pro (6.0, Mac & Windows) based package (<http://usaxs.xor.aps.anl.gov/>) – free but need Igor Pro license (<http://www.wavemetrics.com/>), \$550/\$395 for user license.
  - Igor Pro scripts are open source and can be modified by anyone. – Open source

# Advanced X-Ray Scattering at NSLS II

- Complex Materials Scattering (CMS) 2016: unique, automated high-throughput material exploration
- Soft Matter Interfaces (SMI) 2016-17: unique, high-performance undulator-based
- Wide energy range (2 to 24 keV) will enable new resonant scattering experiments on hybrid (soft/hard) materials
- Wide  $q$ -range for studies of hierarchical materials
- Microbeams ( $\sim 2 \mu\text{m}$ ) for mapping of heterogeneous samples
- High-flux and fast detectors for kinetic, in-situ, and in-operando experiments



# Useful Material

- Heimo Schnablegger & Yashveer Singh, “The SAXS Guide”
- O. Glaeser & O. Kratky, “Small-Angle X-ray Scattering”, 1982, available free on line.
- Ryong-Joon Roe, “Methods of X-ray and Neutron Scattering in Polymer Science”
- D. Svergun and M. Koch, “Small-angle scattering studies of biological macromolecules in solution”, Rep. Prog. Phys. 66 (2003) 1735–1782.
- Software: Irena, Nika

## Acknowledgments

**Lin Yang, Masa Fukuto, Kevin Yager, Dmytro Nykypanchuk,  
Mikhail Zhernenkov (BNL)**

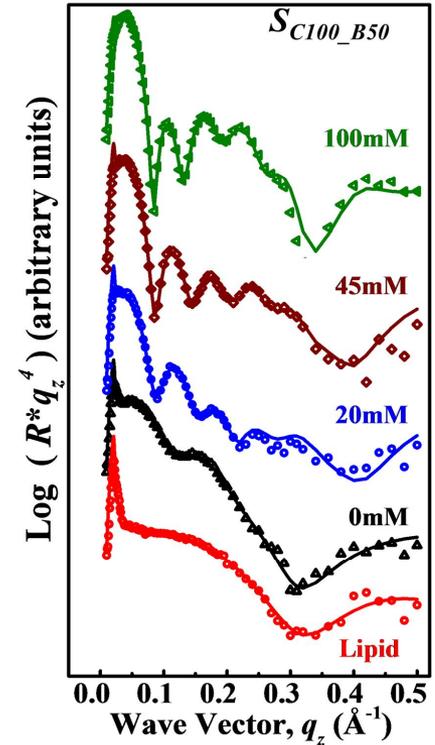
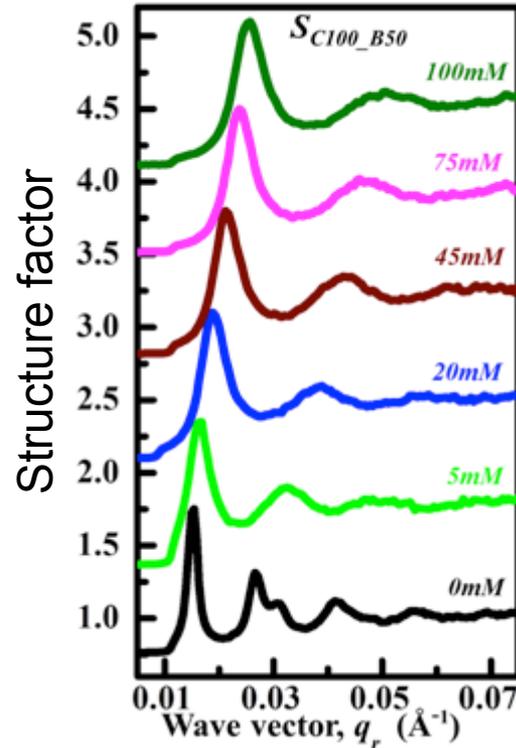
**Franck Artzner (U. Rennes, France), Jan Ilavsky (ANL)**

**Online materials from Rigaku and scattering schools**

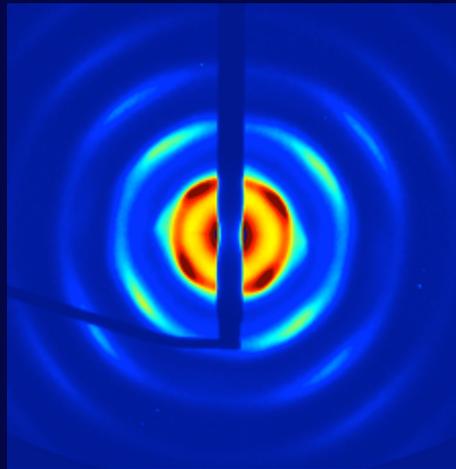
# Assignment

1. Derive a radius of gyration for the shell of given thickness and diameter.

2. Your colleague obtained x-ray reflectivity (right) and grazing incidence diffraction (left) data from the nanoparticle monolayer at different salt conditions and for the underlying lipid layer. Provide your interpretation of the monolayer structure and its evolution using the plots. Does monolayer have in-plane order? What kind? How do the order and the correlation length (assume no contribution from resolution) change with salt increase? What is the thickness of the monolayer? Can you tell anything about nanoparticle shell from this estimation?



# Small Angle X-Ray Scattering (SAXS) from Bulks and Surfaces



Oleg Gang (ogang@bnl.gov)  
Center for Functional Nanomaterials  
Brookhaven National Laboratory  
Upton, NY, USA